

# MLX90293 Linear Hall Position Sensor IC

## Datasheet

### Features and Benefits

- Linear Hall Position Sensor IC
- Non-linear Magnetic Design with Linear Output Signal
- Programmable Transfer Characteristic to compensate system non-linearity and thermal drift:
  - Over Position : 16 segments – Piece-Wise-Linear
  - Thermal Drift over Temperature : Sensitivity and Offset : 6 segments - Piece-Wise-Linear<sup>(1)</sup>
- Selectable Output Mode:
  - Analog (Ratiometric)
  - Pulse Width Modulation (PWM)
  - SENT (according to SAE J2716-2010)
- 12 bit Resolution - 10 bit Thermal Accuracy
- Open/Short Diagnostics
- Over-Voltage Protection
- Under-Voltage Detection
- 48 bit ID Number option
- AEC-Q100 Qualified
- Single Die – SOIC-8 Package RoHS Compliant
- Dual Die (Full Redundant) – TSSOP-16 Package RoHS Compliant



SOIC-8



TSSOP-16

### Applications

- Absolute Small Angle Rotary Position Sensor
- Absolute Small Stroke Linear Position Sensor
- Pedal Position Sensor
- Non-Contacting Potentiometer

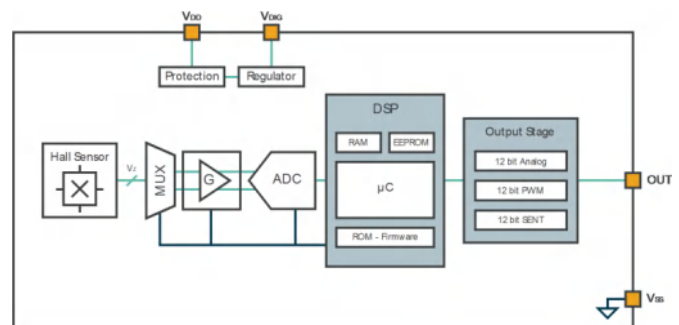
### Description

The MLX90293 is a SMD Programmable Linear Hall Sensor IC that enables contact less position sensor applications.

The sensor measures the magnetic field component perpendicular to the surface of the IC. The MLX90293 supports multiple output modes, such as analog, PWM and SENT 2010.

The MLX90293 enables extensive nonlinear optimization of the transfer characteristic. Such optimization in turn enables simplified magnetic designs. The result is a linear output characteristic over position after calibration.

The customer can program this relation in his end-of-line calibration through the connector with Melexis tooling.



<sup>1</sup> IC is trimmed at Melexis to achieve minimized IC sensitivity & offset drift over temperature. Customers can trim the sensitivity & offset drift of the application over temperature.

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## 1. Ordering Information

| Product Code | Temperature Code | Package Code | Option Code | Packing Form |
|--------------|------------------|--------------|-------------|--------------|
| MLX90293     | E                | DC           | ADM-000     | RE           |
| MLX90293     | L                | DC           | ADM-000     | RE           |
| MLX90293     | E                | GO           | ADM-000     | RE           |
| MLX90293     | L                | GO           | ADM-000     | RE           |
| MLX90293     | E                | DC           | ADM-100     | RE           |
| MLX90293     | L                | DC           | ADM-100     | RE           |
| MLX90293     | E                | GO           | ADM-100     | RE           |
| MLX90293     | L                | GO           | ADM-100     | RE           |

### Legend:

|                   |                                                                 |
|-------------------|-----------------------------------------------------------------|
| Temperature Code: | E: from -40 Deg.C to 85 Deg.C<br>L: from -40 Deg.C to 150 Deg.C |
| Package Code:     | "DC" for SOIC-8 package<br>"GO" for TSSOP-16 package (dual die) |
| Option Code:      | ADM-000 – Default<br>ADM-100 – Low thermal drift                |
| Packing Form:     | "RE" for Reel<br>"SP" for Sample Pack                           |
| Ordering Example: | MLX90293LGO-ADM-100-RE                                          |

*Table 1 - Legend*

## 2. Functional Diagram

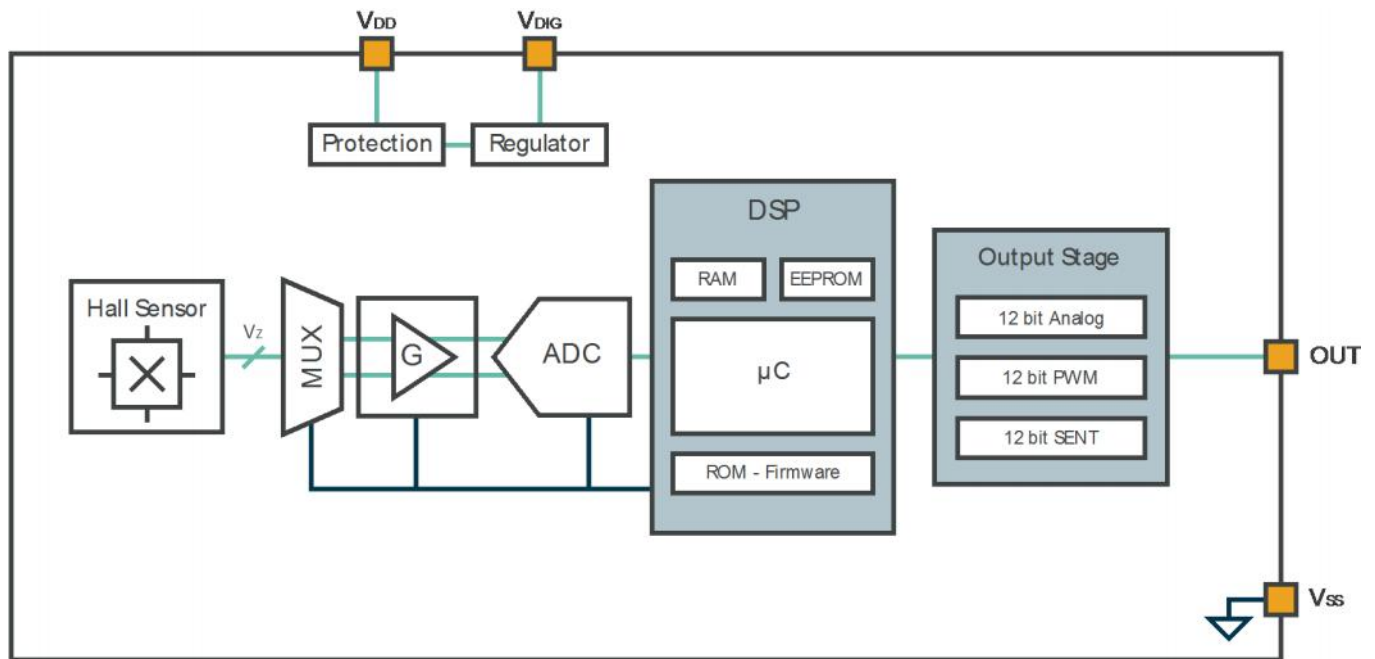


Figure 1 - Block Diagram

## 3. Glossary of Terms

|                      |                                                         |
|----------------------|---------------------------------------------------------|
| Gauss (G), Tesla (T) | Units for the magnetic flux density - 1 mT = 10 G       |
| TC                   | Temperature Coefficient (in ppm/Deg.C.)                 |
| NC                   | Not Connected                                           |
| PWM                  | Pulse Width Modulation                                  |
| ADC                  | Analog-to-Digital Converter                             |
| LSB                  | Least Significant Bit                                   |
| MSB                  | Most Significant Bit                                    |
| DNL                  | Differential Non-Linearity                              |
| INL                  | Integral Non-Linearity                                  |
| RISC                 | Reduced Instruction Set Computer                        |
| ASP                  | Analog Signal Processing                                |
| DSP                  | Digital Signal Processing                               |
| ATAN                 | Trigonometric function: arctangent (or inverse tangent) |
| IMC                  | Integrated Magneto-Concentrator (IMC®)                  |
| CoRDIC               | Coordinate Rotation Digital Computer                    |

|      |                                                                                                      |
|------|------------------------------------------------------------------------------------------------------|
|      | (i.e. iterative rectangular-to-polar transform)                                                      |
| EMC  | Electro-Magnetic Compatibility                                                                       |
| FE   | Falling Edge                                                                                         |
| RE   | Rising Edge                                                                                          |
| FW   | Firmware                                                                                             |
| HW   | Hardware                                                                                             |
| PWM  | Pulse Width Modulation                                                                               |
| %DC  | Ratio Ton / Tperiod where Ton is the high state duration and Tperiod is the duration of 1 pwm period |
| MT3V | More than 3V Condition                                                                               |
| MT4V | More than 4V Condition                                                                               |
| LSD  | Low Side Driver = Open drain N                                                                       |
| PP   | Push-Pull                                                                                            |

Table 2 - Glossary of Terms

## 4. Pinout

| PIN | SOIC-8                   | TSSOP-16                                |
|-----|--------------------------|-----------------------------------------|
| 1   | VDD                      | V <sub>DIG1</sub>                       |
| 2   | Test 0                   | V <sub>SS1</sub> (Ground <sub>1</sub> ) |
| 3   | Test 2                   | VDD <sub>1</sub>                        |
| 4   | Not Used                 | Test 0 <sub>1</sub>                     |
| 5   | OUT                      | Test 2 <sub>2</sub>                     |
| 6   | Test 1                   | OUT <sub>2</sub>                        |
| 7   | V <sub>DIG</sub>         | Not Used <sub>2</sub>                   |
| 8   | V <sub>SS</sub> (Ground) | Test 1 <sub>2</sub>                     |
| 9   |                          | V <sub>DIG2</sub>                       |
| 10  |                          | V <sub>SS2</sub> (Ground <sub>2</sub> ) |
| 11  |                          | VDD <sub>2</sub>                        |
| 12  |                          | Test 0 <sub>2</sub>                     |
| 13  |                          | Test 2 <sub>1</sub>                     |
| 14  |                          | Not Used <sub>1</sub>                   |
| 15  |                          | OUT <sub>1</sub>                        |
| 16  |                          | Test 1 <sub>1</sub>                     |

For optimal EMC behavior, it is recommended to connect the unused pins (Not Used and Test) to the Ground (see section 16).

## 5. Absolute Maximum Ratings

DC Operating Parameters at Nominal Supply Voltage (unless otherwise specified) and for Application Temperature Range  $T_A$  as specified by the Temperature Code.

| Parameter                                  | Value                       |
|--------------------------------------------|-----------------------------|
| Supply Voltage, VDD (overvoltage)          | + 24 V                      |
| Reverse Voltage Protection                 | – 12 V (breakdown at -14 V) |
| Positive Output Voltage                    | + 18 V (breakdown at 24 V)  |
| Output Current (I <sub>OUT</sub> )         | + 30 mA (in breakdown)      |
| Reverse Output Voltage                     | – 0.3 V                     |
| Reverse Output Current                     | – 50 mA (in breakdown)      |
| Operating Ambient Temperature Range, $T_A$ | – 40 ... + 150 Deg.C        |
| Storage Temperature Range, $T_S$           | – 40 ... + 150 Deg.C        |
| Magnetic Flux Density                      | ± 1 T                       |

Exceeding the absolute maximum ratings may cause permanent damage. Exposure to absolute maximum-rated conditions for extended periods may affect device reliability.

## 6. Electrical Specification

DC Operating Parameters at Nominal Supply Voltage (unless otherwise specified) and for Application Temperature Range  $T_A$  as specified by the Temperature Code.

| Parameter                                                                   | Symbol              | Test Conditions                                                                                           | Min        | Typ        | Max               | Units                           |
|-----------------------------------------------------------------------------|---------------------|-----------------------------------------------------------------------------------------------------------|------------|------------|-------------------|---------------------------------|
| Nominal Supply Voltage                                                      | V <sub>DD</sub>     |                                                                                                           | 4.5        | 5          | 5.5               | V                               |
| Supply Current <sup>(2)</sup>                                               | I <sub>DD</sub>     | Power saving Enabled                                                                                      |            | 6          | 10 <sup>(3)</sup> | mA                              |
| Isurge Current <sup>(4)</sup>                                               | I <sub>surge</sub>  |                                                                                                           |            |            | 20                | mA                              |
| Power-On reset (rising)                                                     | HPOR_LH             | Refer to internal voltage V <sub>dig</sub>                                                                | 2          | 2.25       | 2.5               | V                               |
| Power-On reset Hysteresis                                                   | HPOR_Hyst           |                                                                                                           | 50         |            | 200               | mV                              |
| Start-up Level (rising)                                                     | MT4V_LH             |                                                                                                           | 3.8        | 4.0        | 4.2               | V                               |
| Start-up Hysteresis                                                         | MT4V_Hyst           |                                                                                                           | 50         |            | 200               | mV                              |
| PTC Entry Level (rising)                                                    | MT7V_LH             |                                                                                                           | 5.8        | 6.2        | 6.6               | V                               |
| PTC Entry Level Hysteresis                                                  | MT7V_Hyst           |                                                                                                           | 50         |            | 200               | mV                              |
| Output Short Circuit Current                                                | I <sub>short</sub>  | V <sub>out</sub> = 0 V                                                                                    |            |            | 15                | mA                              |
|                                                                             |                     | V <sub>out</sub> = 5 V                                                                                    |            |            | 15                | mA                              |
|                                                                             |                     | V <sub>out</sub> = 18 V ( $T_A = 25\text{Deg.C}$ )                                                        |            |            | 18                | mA                              |
| Output Load                                                                 | R <sub>L</sub>      | Pull-down to Ground                                                                                       | 4.7        | 10         |                   | kΩ                              |
|                                                                             |                     | Pull-up to 5V                                                                                             | 4.7        | 10         |                   | kΩ                              |
| Analog Saturation Output Level                                              | V <sub>sat_lo</sub> | Pull-up load R <sub>L</sub> ≥ 10 kΩ to 5 V<br>Pull-up load R <sub>L</sub> ≥ 5 kΩ to 18                    |            | 0.5<br>2   | 2<br>3            | %V <sub>DD</sub>                |
|                                                                             | V <sub>sat_hi</sub> | Pull-down load R <sub>L</sub> ≥ 5 kΩ<br>Pull-down load R <sub>L</sub> ≥ 10 kΩ                             | 95<br>97.5 | 97<br>98.5 |                   | %V <sub>DD</sub>                |
| Active Diagnostic Output Level                                              | Diag_lo             | Pull-up load R <sub>L</sub> ≥ 10 kΩ to 5 V<br>Pull-up load R <sub>L</sub> ≥ 5 kΩ to 18V                   |            | 0.5<br>2   | 2<br>3            | %V <sub>DD</sub>                |
|                                                                             | Diag_hi             | Pull-down load R <sub>L</sub> ≥ 5 kΩ<br>Pull-down load R <sub>L</sub> ≥ 10 kΩ                             | 95<br>97.5 | 97<br>98.5 |                   | %V <sub>DD</sub>                |
| Passive Diagnostic Output Level<br>(Broken Track Diagnostic) <sup>(5)</sup> | BV <sub>ssPD</sub>  | Broken V <sub>ss</sub> &<br>Pull-down load R <sub>L</sub> ≥ 5 kΩ<br>Pull-down load R <sub>L</sub> ≥ 10 kΩ | 95<br>97.5 |            |                   | %V <sub>DD</sub>                |
|                                                                             | BV <sub>ssPU</sub>  | Broken V <sub>ss</sub> &<br>Pull-up load R <sub>L</sub> ≥ 1kΩ                                             | 99.5       | 100        |                   | %V <sub>DD</sub>                |
|                                                                             | BV <sub>DDPD</sub>  | Broken V <sub>DD</sub> &<br>Pull-down load R <sub>L</sub> ≥ 1kΩ                                           |            | 0          | 0.5               | %V <sub>DD</sub>                |
|                                                                             | BV <sub>DDPU</sub>  | Broken V <sub>DD</sub> &<br>Pull-up load R <sub>L</sub> ≥ 5kΩ                                             |            |            | 2                 | %V <sub>DD</sub>                |
| Clamped Output Level                                                        | Clamp_lo            | Programmable                                                                                              | 0          |            | 100               | %V <sub>DD</sub> <sup>(6)</sup> |
|                                                                             | Clamp_hi            | Programmable                                                                                              | 0          |            | 100               | %V <sub>DD</sub> <sup>(6)</sup> |

2 For the dual version, the supply current is multiplied by 2.

3 To reach 10mA, the power saving option is enabled. This option switches off and on internal blocks dynamically. It can be disabled to reduce emission and meet stringent EMC requirements; the maximum supply current consumption then is increased up to 12mA.

4 The specified value is valid during early start-up time only; the current might dynamically exceed the specified value, shortly, during the Start-up phase.

5 For detailed information, see also section on Diagnostics

6 Clamping levels need to be considered vs the saturation of the output stage (see V<sub>sat\_lo</sub> and V<sub>sat\_hi</sub>)

As an illustration of the previous table, the MLX90293 fits the typical classification of the output span described on the Figure 2.

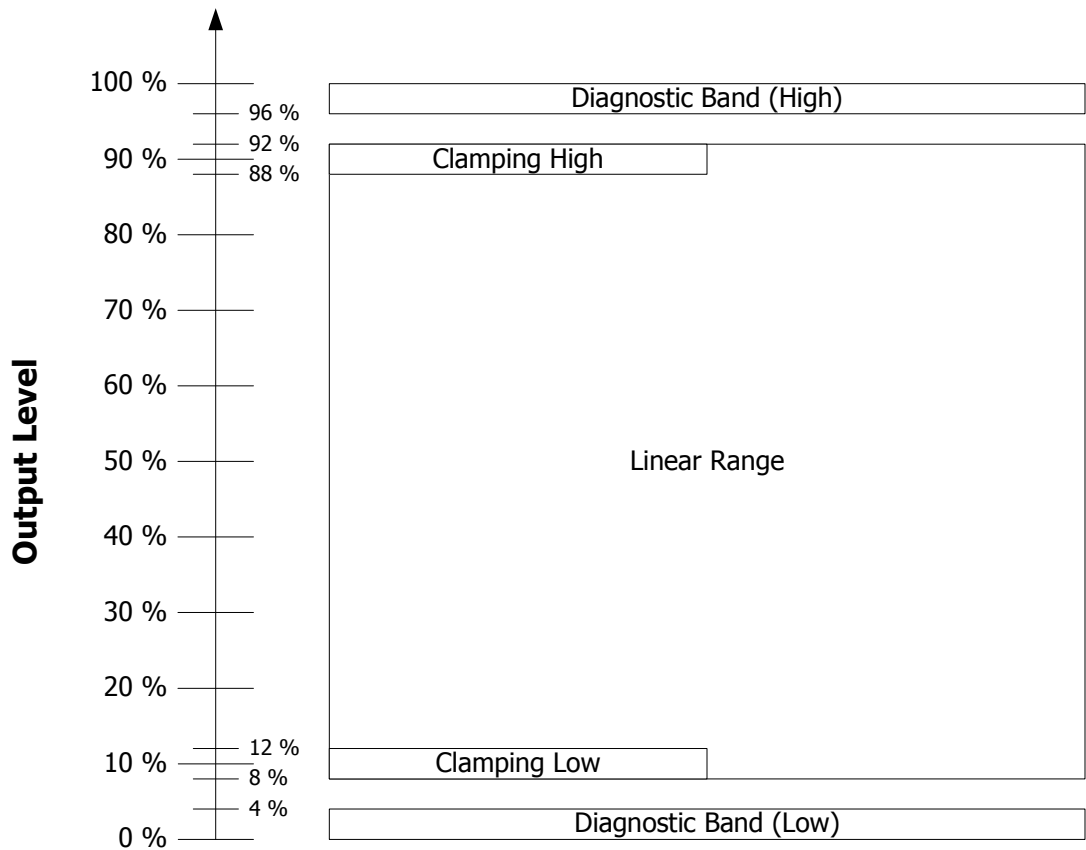


Figure 2 - Example of Output Span Classification for typical application

## 7. Isolation Specification

DC Operating Parameters at Nominal Supply Voltage (unless otherwise specified) and for Application Temperature Range  $T_A$  as specified by the Temperature Code. Only valid for the Package Code GO i.e. dual die version.

| Parameter            | Symbol | Test Conditions | Min | Typ | Max | Units |
|----------------------|--------|-----------------|-----|-----|-----|-------|
| Isolation Resistance |        | Between dice    | 4   |     |     | MΩ    |

## 8. Timing Specification

### 8.1. Generic Timings

DC Operating Parameters at Nominal Supply Voltage (unless otherwise specified) and for Application Temperature Range  $T_A$  as specified by the Temperature Code. These timings hold true regardless of the chosen communication protocol.

| Parameter                          | Symbol               | Test Conditions                         | Min   | Typ  | Max       | Units             |
|------------------------------------|----------------------|-----------------------------------------|-------|------|-----------|-------------------|
| Main Clock Frequency               | Ck                   | All contributors included thermal drift | 12.6  | 13.3 | 14        | MHz               |
| Main Clock Frequency Thermal Drift | $\Delta^T \text{Ck}$ |                                         |       |      | $\pm 3\%$ | Ck <sub>NOM</sub> |
| Watchdog                           | Twd                  |                                         | 114.5 | 118  | 121.5     | ms                |

### 8.2. Timings in Analog/PWM mode

DC Operating Parameters at Nominal Supply Voltage (unless otherwise specified) and for Application Temperature Range  $T_A$  as specified by the Temperature Code.

| Parameter                         | Symbol | Test Conditions                                                                                                                                                                  | Min                    | Typ                    | Max | Units                            |
|-----------------------------------|--------|----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|------------------------|------------------------|-----|----------------------------------|
| Refresh Period                    | ts     |                                                                                                                                                                                  |                        | 441                    |     | $\mu\text{s}$                    |
| Latency over Refresh Period ratio |        | Filter=0 <sup>(7)</sup><br>Filter=1<br>Filter=2<br>IIR is described separately in section 14.6                                                                                   |                        | 1.5<br>2<br>3          |     | ts [refresh rate] <sup>(8)</sup> |
| Start-up Cycle                    | Tsu    | Analog OUT Slew-rate excluded                                                                                                                                                    |                        |                        | 10  | ms                               |
| Analog OUT Slew-rate              |        | Mode 1<br>from C <sub>OUT</sub> = 47 nF to 330 nF<br>Mode 2: up to C <sub>OUT</sub> = 10 nF<br>Mode 3: up to C <sub>OUT</sub> = 47 nF<br>Mode 4: up to C <sub>OUT</sub> = 330 nF | 25<br>300<br>17<br>1.8 | 37<br>320<br>19<br>2.5 |     | V/ms                             |

### 8.3. Timings specific for PWM Protocol

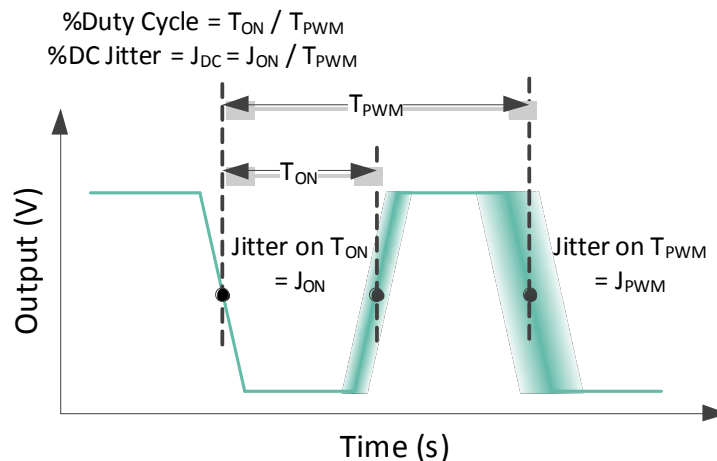
DC Operating Parameters at  $V_{DD} = V_{PU} = 5V$  (unless otherwise specified) and for  $T_A$  as specified by the Temperature Code.

<sup>7</sup> See section 14.6 for details concerning Filter parameter

<sup>8</sup> The step response time is the Refresh Period times ts. So, the step response time of filter = 1 is  $882\mu\text{s} = 2 \times 441\mu\text{s}$

| Parameter                                          | Symbol | Test Conditions                                                                                                                                                                                                                                                                                           | Min | Typ                                                      | Max                                                    | Units   |
|----------------------------------------------------|--------|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-----|----------------------------------------------------------|--------------------------------------------------------|---------|
| PWM Output Resolution                              | RPWM   | 12 bits                                                                                                                                                                                                                                                                                                   |     | 0.025                                                    |                                                        | %DC/LSB |
| PWM % DC Jitter                                    | JDC    | LSD – Mode5<br>100Hz, 4.7nF, $R_L = 1\text{ k}\Omega$ PU<br>200Hz, 4.7nF, $R_L = 1\text{ k}\Omega$ PU<br>1000Hz, 4.7nF, $R_L = 1\text{ k}\Omega$ PU<br>PP – Mode7<br>100Hz, 4.7nF, $R_L = 1\text{ k}\Omega$ PU<br>200Hz, 4.7nF, $R_L = 1\text{ k}\Omega$ PU<br>1000Hz, 4.7nF, $R_L = 1\text{ k}\Omega$ PU |     | ±0.003<br>±0.005<br>±0.009<br>±0.003<br>±0.005<br>±0.009 | ±0.016<br>±0.02<br>±0.035<br>±0.016<br>±0.02<br>±0.035 | %DC     |
| PWM Freq Jitter                                    | JPWM   | LSD – Mode5<br>100-1000 Hz, 4.7nF, $R_L = 1\text{ k}\Omega$ PU<br>PP – Mode7<br>100-1000 Hz, 4.7nF, $R_L = 1\text{ k}\Omega$ PU                                                                                                                                                                           |     | ±0.04<br>±0.04                                           | ±0.15<br>±0.15                                         | Hz      |
| PWM % DC thermal drift                             |        | LSD – Mode5<br>100Hz, 4.7nF, $R_L = 1\text{ k}\Omega$ PU<br>200Hz, 4.7nF, $R_L = 1\text{ k}\Omega$ PU<br>1000Hz, 4.7nF, $R_L = 1\text{ k}\Omega$ PU<br>PP – Mode7<br>100Hz, 4.7nF, $R_L = 1\text{ k}\Omega$ PU<br>200Hz, 4.7nF, $R_L = 1\text{ k}\Omega$ PU<br>1000Hz, 4.7nF, $R_L = 1\text{ k}\Omega$ PU |     | ±0.02<br>±0.02<br>±0.02<br>±0.02<br>±0.02<br>±0.02       | ±0.03<br>±0.03<br>±0.05<br>±0.03<br>±0.03<br>±0.05     | %DC     |
| PWM % DC Level drift<br>(Trigger level= 25/50/75%) |        | LSD – Mode5<br>100Hz, 4.7nF, $R_L = 1\text{ k}\Omega$ PU<br>PP – Mode7<br>100Hz, 4.7nF, $R_L = 1\text{ k}\Omega$ PU                                                                                                                                                                                       |     | ±0.1<br>±0.05                                            | ±0.15<br>±0.1                                          | %DC     |
| PWM % DC Level drift                               |        | 100Hz – PP<br>Application Diagram (see below)<br>$R_s = 0, 50, 100, 150\text{ Ohm}$<br>Tolerance on R ± 20%<br>Tolerance on C ± 30%                                                                                                                                                                       |     | ±0.05                                                    | ±0.1                                                   | %DC     |

Jitter is defined by  $\pm 3\sigma$  for 1000 successive acquisitions with clamped output, see Figure below.



| Parameter            | Symbol      | Test Conditions                                 |
|----------------------|-------------|-------------------------------------------------|
| PWM TON, TPWM        | TON<br>TPWM | Trigger level = 50 % Vpp                        |
| Rise time, Fall time |             | 10% and 90% of amplitude                        |
| Jitter               | JON<br>JPWM | $\pm 3 \sigma$ for 1000 successive acquisitions |
| Duty Cycle           | % DC        | TON / TPWM                                      |

Figure 3 - MLX90293 PWM measurement conditions.

## 8.4. Timings in SENT mode

DC Operating Parameters at Nominal Supply Voltage (unless otherwise specified) and for Application Temperature Range  $T_A$  as specified by the Temperature Code.

| Parameter                                                            | Symbol  | Test Conditions                                        | Min  | Typ  | Max | Units   |
|----------------------------------------------------------------------|---------|--------------------------------------------------------|------|------|-----|---------|
| Tick time <sup>(9)</sup>                                             |         | Ck = 13.3 MHz                                          |      | 3    |     | $\mu s$ |
| SENT Frame Period <sup>(10)</sup>                                    | tframe  | Ck = 13.3 MHz                                          |      | 882  |     | $\mu s$ |
| Maximal SENT Frame Tick Count <sup>(11)</sup> (pause pulse disabled) |         |                                                        |      | 256  |     | ticks   |
| Internal Measurement Period <sup>12</sup>                            | Tper    | Ck = 13.3 MHz                                          |      | 441  |     | $\mu s$ |
| First Measurement to Sync Pulse latency                              | ta1     | Ck = 13.3 MHz                                          |      | 1084 |     | $\mu s$ |
| Second Measurement to Sync Pulse latency                             | ta2     | Ck = 13.3 MHz                                          |      | 643  |     | $\mu s$ |
| Latency (in case of Synchronous communication)                       | Latency | FILTER = 1 (recommended)<br>SENT Transmission Included | 1745 | 1745 |     | $\mu s$ |
| Start-up Time (up to first sync pulse)                               | tsu1    |                                                        |      | 1.8  |     | ms      |
| Start-up Time (up to first data received)                            | tsu2    | Last pause pulse not included                          |      | 7.5  | 8.1 | ms      |
| Serial Message                                                       |         | Extended sequence (18 frames)                          |      | 15.9 |     | ms      |
|                                                                      |         | Short sequence ( 8 frames)                             |      | 7.1  |     | ms      |
| Rise Time @ Cable                                                    |         | Thresholds : 0.5V and 4.5V                             | 3.0  |      | 5.3 | $\mu s$ |
| Rise Time @ Receiver                                                 |         |                                                        | 5.1  |      | 6.8 | $\mu s$ |
| Fall Time @ Cable                                                    |         |                                                        | 2.7  |      | 2.8 | $\mu s$ |
| Fall Time @ Receiver                                                 |         |                                                        | 4.8  |      | 4.9 | $\mu s$ |

<sup>9</sup> Tick time scales with Main Clock Frequency. Variation of Tick time for one IC is given by the Main Clock Frequency Thermal Drift.

<sup>10</sup> This frame period with pause pulse enabled ensures synchronous communication. Synchronous means the time between data acquisition & signal transmitted in a SENT frame is fixed.

<sup>11</sup> Length of frame depends on pause pulse enabled/disabled. The pause pulse and thus the frame length can be varied. A typical SENT frame is 56 ticks for the sync pulse, 8 nibble packages which vary between 12 & 25 ticks and an optional pause pulse which is at minimal 12 ticks.

<sup>12</sup> This period is used if the pause pulse is enabled. If disabled, the Internal Measurement Period = 551 $\mu s$ , i.e. 25% higher.

# 8.5. Timing diagrams

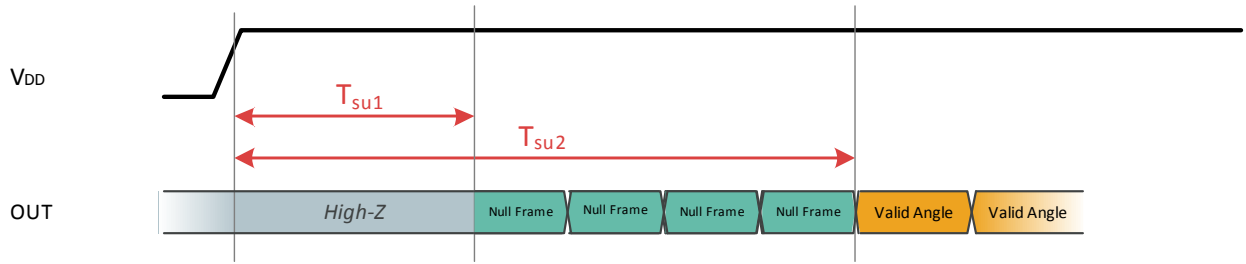


Figure 4 - Start-up phase timings

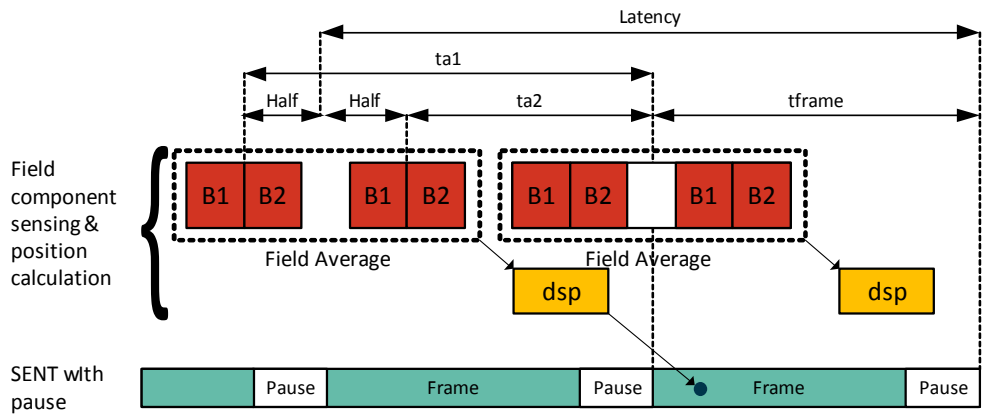


Figure 5 - Latencies (acquisition to output delays) – FILTER = 1 (recommended) Two readouts are averaged.  
Note: B1/B2 are needed to get one field readout.

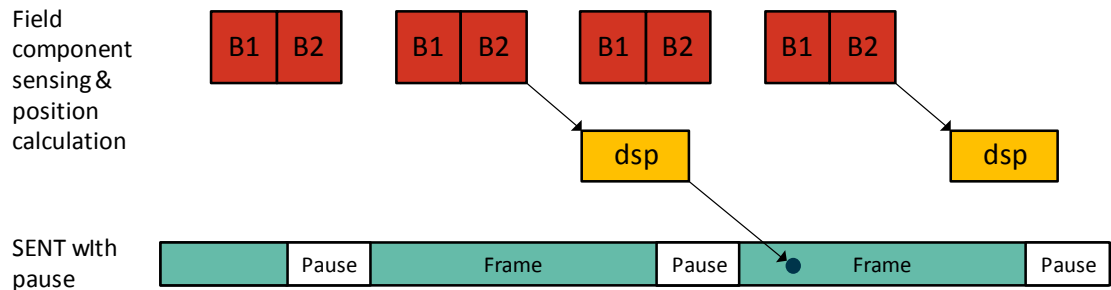


Figure 6 - Latency - Case FILTER = 0 (not recommended). The difference between Filter=0 & Filter =1 is that Filter =0 skips one acquisition of B1/B2.

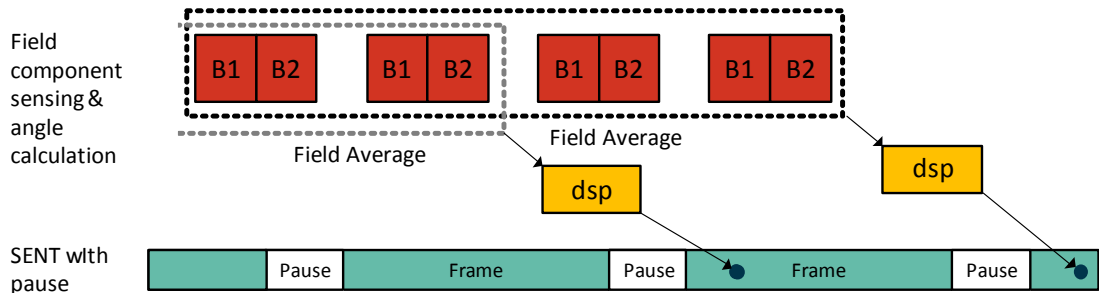


Figure 7 - Latency - Case FILTER = 2

## 8.6. Application diagram used for rise and fall time measurement

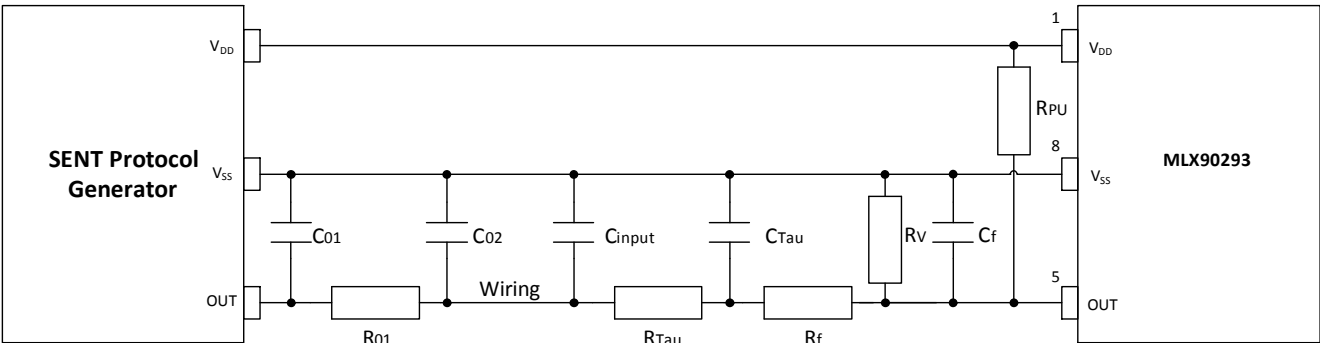


Figure 8 - Schematic used for rise and fall time measurements (ref: J2716 Rev Jan 2010 Fig. 6.3.4)

| Component | Value       | Unit |
|-----------|-------------|------|
| C01       | 10 ± 25%    | nF   |
| C02       | not mounted | nF   |
| R01       | not mounted | Ω    |
| Cinput    | 68          | pF   |
| CTau      | 2.2         | nF   |
| Cf        | 100         | pF   |
| RTau      | 568         | Ω    |
| Rf        | 10          | kΩ   |
| RPU       | 14.7        | kΩ   |
| RV        | not mounted | Ω    |

Component values used for rise and fall time measurements (ref: J2716 Rev Jan 2010 Fig. 6.3.4)

## 9. Accuracy specification

DC Operating Parameters at Nominal Supply Voltage (unless otherwise specified) and for Application Temperature Range  $T_A$  as specified by the Temperature Code.

| Parameter                         | Symbol            | Test Conditions                                                          | Min                            | Typ        | Max           | Units          |
|-----------------------------------|-------------------|--------------------------------------------------------------------------|--------------------------------|------------|---------------|----------------|
| ADC Resolution on the raw signals |                   |                                                                          |                                | 15         |               | bits           |
| Thermal Offset Drift              | $\Delta^T V_{OQ}$ | Without system compensation                                              | -0.45 <sup>(13)</sup><br>-0.35 |            | 0.45<br>0.35  | %Span          |
| Analog Output Resolution          | $R_{DAC}$         | 12b DAC (Theoretical, Noise free)<br>INL (before EOL calibration)<br>DNL | -4<br>0.05                     | 0.025<br>1 | +4<br>3       | %VDD/<br>LSB12 |
| Output stage Noise                |                   | Clamped Output                                                           |                                | 0.05       | 0.075         | %VDD           |
| Overall Noise <sup>(14)</sup>     | $3\sigma$         | EE_VG = 21 (=span of 30mT)                                               |                                |            | 0.1           | %VDD           |
| Ratiometry Error <sup>(15)</sup>  |                   | 4.5V $\leq$ VDD $\leq$ 5.5V<br>LT4V $\leq$ VDD $\leq$ MT7V               | -0.05<br>-0.1                  |            | +0.05<br>+0.1 | %VDD           |
| Sensitivity Drift <sup>(16)</sup> | $\Delta^T S$      | Intrinsic IC Sensitivity Drift<br>(Temperature Code=L)                   | -190                           |            | 190           | ppm/Deg.C      |
| Sensitivity Drift <sup>(16)</sup> | $\Delta^T S$      | Intrinsic IC Sensitivity Drift<br>(Temperature Code=E)                   | -150                           |            | 150           | ppm/Deg.C      |

## 10. Magnetic Specification

DC Operating Parameters at Nominal Supply Voltage (unless otherwise specified) and for Application Temperature Range  $T_A$  as specified by the Temperature Code.

| Parameter                                      | Symbol | Test Conditions | Min   | Typ | Max | Units     |
|------------------------------------------------|--------|-----------------|-------|-----|-----|-----------|
| Magnetic Flux Density                          | $B_z$  |                 | -150  |     | 150 | mT        |
| Magnet Temperature Coefficient <sup>(17)</sup> | TCm    |                 | -4000 |     | 0   | ppm/Deg.C |

## 11. CPU & Memory Specification

The DSP is based on a 16 bit RISC  $\mu$ Controller. This CPU provides 2.5 Mips while running at 10 MHz.

13 Parts with lowered thermal offset drift are available. A thermal offset drift within [-0.45%,0.45%] is ordered with MLX90293Exx-ADM-0xx-xx. A thermal offset drift within [-0.35%, 0.35%] is ordered with MLX90293Exx-ADM-1xx-xx.

14 Noise pk-pk (peak-to-peak) is 3 sigma Noise. The application diagram used is described in the recommended wiring. For detailed information, refer to section Filter in application mode (Section 14). This specification is achieved with Hard Filter & IIR filter k=4 while meeting a response time of <1ms

15 Analog output only

16 Lifetime include

17 See also section 14.2

| Parameter | Symbol | Test Conditions | Min | Typ | Max | Units |
|-----------|--------|-----------------|-----|-----|-----|-------|
| ROM       |        |                 |     | 10  |     | KB    |
| RAM       |        |                 |     | 384 |     | B     |
| EEPROM    |        |                 |     | 128 |     | B     |

## 12. Traceability Information

Every device contains a unique ID that is programmed by Melexis in the EEPROM. Melexis strongly recommends storing this value during the EOL (End-Of-Line) programming to ensure full traceability of the final product.

These parameters shall never be erased during the EOL programming.

| Parameter  | Comments                         | Default Values | Parameter # bit |
|------------|----------------------------------|----------------|-----------------|
| MELEXISID1 | Melexis identification reference | MLX            | 16              |
| MELEXISID2 | Melexis identification reference | MLX            | 16              |
| MELEXISID3 | Melexis identification reference | MLX            | 16              |

## 13. End-User Programmable Items

| Parameter                    | Function or Comment                                                          | Default                                         | Remark                                                       |
|------------------------------|------------------------------------------------------------------------------|-------------------------------------------------|--------------------------------------------------------------|
| EE_VG                        | Analog Gain <sup>18</sup>                                                    | 14h                                             | Default : analog gain = 20                                   |
| EE_OSMOD                     | Output stage configuration                                                   | F4h                                             | (19)                                                         |
| EE_USERCFG0                  | User configuration 0                                                         | 00h                                             | (19)                                                         |
| EE_USERCFG1                  | User configuration 1                                                         | A2h<br>For Zx;<br>depends on<br>field direction | (19)                                                         |
| EE_USERCFG2                  | User configuration 2                                                         | 00h                                             | (19)                                                         |
| EE_CALIBMODE_L               | Calibration coefficients                                                     | 00h                                             | Enables extreme thermal compensation scaling <sup>(19)</sup> |
| EE_SERIAL_ID_1 /<br>EE_PWMTL | ID of user serial message #1 / PWM period lsbyte                             | D0h                                             | (20)                                                         |
| EE_SERIAL_ID_2 /<br>EE_PWMTH | ID of user serial message #2 / PWM period msbyte                             | 07h                                             | (20)                                                         |
| EE_SERIAL_ID_3 /<br>EE_PWMDC | ID of user serial message #3 / PWM duty cycle (when in fault reporting mode) | 00                                              |                                                              |
| EE_SERIAL_ID_4               | ID of user serial message #4                                                 | 0x00                                            |                                                              |
| EE_SSYS12                    | {EE_Ssys2, EE_Ssys1}                                                         | 00h                                             | Signed 2's complement <sup>(21)</sup>                        |
| EE_SSYS35                    | {EE_Ssys5, EE_Ssys3}                                                         | 00h                                             | (21)                                                         |
| EE_SSYS67                    | {EE_Ssys7, EE_Ssys6}                                                         | 00h                                             | (21)                                                         |

<sup>18</sup> The setting of the analog gain must be done in order to prevent ADC saturation that can lead to a measurement error, please contact Melexis. See also ADC Clipping section 15

<sup>19</sup> See section 14.1.1

<sup>20</sup> See section 14.1.2

<sup>21</sup> See section 14.2.5

| Parameter                 | Function or Comment                                          | Default | Remark                                                                                                                                                                                                                                                            |
|---------------------------|--------------------------------------------------------------|---------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| EE_SERIAL_DATA_1 / OSYS12 | User SENT serial data / {EE_OSYS2, EE_OSYS1}                 | 0000h   | If Sent serial messages are used, piecewise linear compensation cannot be used for the system's offset drift and vice versa. System sensitivity drift is always available. The IC is optimized by Melexis to reduce IC offset & sensitivity drift <sup>(22)</sup> |
| EE_SERIAL_DATA_2 / OSYS35 | User SENT serial data / {EE_OSYS3, EE_OSYS5}                 | 0000h   |                                                                                                                                                                                                                                                                   |
| EE_SERIAL_DATA_3 / OSYS67 | User SENT serial data / {EE_OSYS6, EE_OSYS7}                 | 0000h   |                                                                                                                                                                                                                                                                   |
| EE_SERIAL_DATA_4 / IIR_K  | Data of user serial message #4                               | 0000h   | EE_SERIAL_DATA_4 or IIR_K <sup>(23)</sup> if FILTER <sup>(19)</sup> =3                                                                                                                                                                                            |
| EE_DIGOFFSETIN            | Digital offset enabling pre-scaling at start of customer DSP | E0h     | Signed word <sup>(24)</sup>                                                                                                                                                                                                                                       |
| EE_DIGGAININ              | Digital gain enabling scaling at start of customer DSP       | 10h     | Unsigned word <sup>(24)</sup>                                                                                                                                                                                                                                     |
| EE_BPivot                 | Customer pivot point for temperature compensation (Byte)     | 80h     | 50% output span <sup>(25)</sup>                                                                                                                                                                                                                                   |
| EE_LNR_Y0                 | Y coordinate point 0/16                                      | 0000h   | -50% output span <sup>(25)</sup>                                                                                                                                                                                                                                  |
| EE_LNR_Y1                 | Y coordinate point 1/16                                      | 1000h   |                                                                                                                                                                                                                                                                   |
| EE_LNR_Y2                 | Y coordinate point 2/16                                      | 2000h   |                                                                                                                                                                                                                                                                   |
| EE_LNR_Y3                 | Y coordinate point 3/16                                      | 3000h   |                                                                                                                                                                                                                                                                   |
| EE_LNR_Y4                 | Y coordinate point 4/16                                      | 4000h   |                                                                                                                                                                                                                                                                   |
| EE_LNR_Y5                 | Y coordinate point 5/16                                      | 5000h   |                                                                                                                                                                                                                                                                   |
| EE_LNR_Y6                 | Y coordinate point 6/16                                      | 6000h   |                                                                                                                                                                                                                                                                   |
| EE_LNR_Y7                 | Y coordinate point 7/16                                      | 7000h   |                                                                                                                                                                                                                                                                   |
| EE_LNR_Y8                 | Y coordinate point 8/16                                      | 8000h   |                                                                                                                                                                                                                                                                   |
| EE_LNR_Y9                 | Y coordinate point 9/16                                      | 9000h   |                                                                                                                                                                                                                                                                   |
| EE_LNR_Y10                | Y coordinate point 10/16                                     | A000h   |                                                                                                                                                                                                                                                                   |
| EE_LNR_Y11                | Y coordinate point 11/16                                     | B000h   |                                                                                                                                                                                                                                                                   |
| EE_LNR_Y12                | Y coordinate point 12/16                                     | C000h   |                                                                                                                                                                                                                                                                   |
| EE_LNR_Y13                | Y coordinate point 13/16                                     | D000h   |                                                                                                                                                                                                                                                                   |
| EE_LNR_Y14                | Y coordinate point 14/16                                     | E000h   |                                                                                                                                                                                                                                                                   |
| EE_LNR_Y15                | Y coordinate point 15/16                                     | F000h   |                                                                                                                                                                                                                                                                   |
| EE_LNR_Y16                | Y coordinate point 16/16                                     | FFFFh   | 150% output span <sup>(25)</sup>                                                                                                                                                                                                                                  |
| EE_CLAMPLOW               | Clamping Low                                                 | 8000h   | 50% <sup>(25)</sup>                                                                                                                                                                                                                                               |
| EE_CLAMPHIGH              | Clamping High                                                | 8000h   | 50% <sup>(25)</sup>                                                                                                                                                                                                                                               |
| EE_DIGOFFSETOUT           | Digital offset enabling scaling in the customer DSP          | 00h     | Signed word <sup>(24)</sup>                                                                                                                                                                                                                                       |

<sup>22</sup> See section 14.2.4

<sup>23</sup> See section 14.6.2

<sup>24</sup> See section 14.2.2

<sup>25</sup> See section 14.2.3

| Parameter                           | Function or Comment                                                                                                                                             | Default | Remark                                                                                                                                                                                      |
|-------------------------------------|-----------------------------------------------------------------------------------------------------------------------------------------------------------------|---------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| EE_DIGGAINOUT                       | Digital gain enabling scaling at start of customer DSP                                                                                                          | 04h     | Unsigned word<br>DIGGAINOUT & DIGOFFSETOUT shall not be changed unless a unipolar application where $\text{maxField} / \text{minField} < 2$ . Contact Melexis in this case. <sup>(24)</sup> |
| EE_SENT_SERIAL                      | SENT sequence options                                                                                                                                           | 08h     | Use User Interface to correctly set this parameter. <sup>(26)</sup>                                                                                                                         |
| EE_ROMCHECKSUM/<br>EE_HARDTHRESHOLD | ROM checksum (when patch is used)<br>Hard Threshold (when hard threshold is enabled)<br>Enabled ROM checksum with patch & Hard Threshold are mutually exclusive | 20h     | Checksum can be skipped with word EE_CRC_DISABLE                                                                                                                                            |
| EE_SENT_CFG                         | {EE_PRESCALER_N[3:0],<br>EE_PRESCALER_M[3:0]}                                                                                                                   | 2Ah     |                                                                                                                                                                                             |
| EE_USERID1                          | User ID1                                                                                                                                                        | 0000h   | <sup>(27)</sup>                                                                                                                                                                             |
| EE_USERID2                          | User ID2                                                                                                                                                        | 0000h   | <sup>(27)</sup>                                                                                                                                                                             |
| EE_USERID3                          | User ID3                                                                                                                                                        | 0000h   | <sup>(27)</sup>                                                                                                                                                                             |
| EE_DIAG_SETTINGS                    | Diagnostics options                                                                                                                                             | 0088h   | <sup>(26)</sup>                                                                                                                                                                             |

Melexis strongly recommends checking the User Identification data (Parameters USERID) during EOL programming.

## 14. Description of End-User Programmable Items

### 14.1. Output modes

#### 14.1.1. Out mode

- EE\_OSMOD determines the Output Stage (Analog, digital, high-impedance, SENT). A distinction is being made between normal operation & start-up or fault.

| EE_OSMOD     |                   |    |    |    |                   |    |    |
|--------------|-------------------|----|----|----|-------------------|----|----|
| B7           | B6                | B5 | B4 | B3 | B2                | B1 | B0 |
| OS_DIAG.DIAG | OS_DIAG.MODE[2:0] |    |    | x  | OS_NORM.MODE[2:0] |    |    |

OS\_DIAG.MODE[2:0] defines the mode when there is a fault, or when in start-up. In all other cases, the output stage is defined by OS\_NORM.MODE[2:0].

<sup>26</sup> See section 14.3.2

<sup>27</sup> See section 14.3.3

| OS_NORM.MODE[2:0] | Type     | Descriptions                            | Comments    |
|-------------------|----------|-----------------------------------------|-------------|
| 0                 | Not used | Not used                                |             |
| 1                 | Analog   | Analog Rail-to-Rail for Coutmin = 47nF  | Analog Only |
| 2                 | Analog   | Analog Rail-to-Rail for Coutmax = 10nF  | Analog Only |
| 3                 | Analog   | Analog Rail-to-Rail for Coutmax = 68nF  | Analog Only |
| 4                 | Analog   | Analog Rail-to-Rail for Coutmax = 330nF | Analog Only |
| 5                 | Digital  | open drain NMOS                         | PWM         |
| 6                 | Digital  | open drain PMOS                         | PWM         |
| 7                 | Digital  | Push-Pull                               | PWM/SENT    |

OS\_DIAG.DIAG determines the reporting level (diagnostic low, diagnostic high) during start-up (both analog and PWM mode), or during a fault reporting (Only in Analog mode).

- Enabling SENT or PWM requires selecting the appropriate Output Stage and enabling the appropriate bit in EE\_USERCFG0. The parameter is defined in the table below.

| Byte           | Bit | Function                                                                                                                                           |
|----------------|-----|----------------------------------------------------------------------------------------------------------------------------------------------------|
| EE_USERCFG0    | 0   | Melexis internal                                                                                                                                   |
|                | 1   | SENT                                                                                                                                               |
|                | 2   | PWM                                                                                                                                                |
|                | 3   | PWMPOL                                                                                                                                             |
|                | 4   | PWMSLEWRATE                                                                                                                                        |
|                | 5   | TREATSEQ[0]                                                                                                                                        |
|                | 6   | TREATSEQ[1]                                                                                                                                        |
|                | 7   | POLARITY                                                                                                                                           |
| EE_USERCFG1    | 0   | MAPXYZ[0]                                                                                                                                          |
|                | 1   | MAPXYZ[1]                                                                                                                                          |
|                | 2   | FILTER[0]                                                                                                                                          |
|                | 3   | FILTER[1]                                                                                                                                          |
|                | 4   | Select_Sent_Osys                                                                                                                                   |
|                | 5   | SENT_pause_nibbleout                                                                                                                               |
|                | 6   | DAC output sign                                                                                                                                    |
|                | 7   | EnableHardThreshold                                                                                                                                |
| EE_USERCFG2    | 0   | Melexis internal                                                                                                                                   |
|                | 1   | Melexis internal                                                                                                                                   |
|                | 2   | Melexis internal                                                                                                                                   |
|                | 3   | free                                                                                                                                               |
|                | 4   | MEMLOCK[0]                                                                                                                                         |
|                | 5   | MEMLOCK[1]                                                                                                                                         |
|                | 6   | Melexis internal                                                                                                                                   |
|                | 7   | Melexis internal                                                                                                                                   |
| EE_CALIBMODE_L | 0   | OutputScaling : scale the output from a span from -50% to 150% output span if True. Otherwise, from 0% to 100% (default : False)                   |
|                | 3   | Ssys2xSpan. The magnet thermal compensation SSYS coefficient goes from [0.5, 1.496] if true. Otherwise, it go from [0.75, 1.248] (default : False) |

### 14.1.2. PWM Output Mode

If PWM output mode is selected, the output signal is a digital signal with Pulse Width Modulation (PWM). The PWM polarity is selected by the PWMPOL parameter (see section 14.1.1):

- PWMPOL = 1 for a low level at 100%
- PWMPOL = 0 for a high level at 100%

The PWM frequency is selected by EE\_PWMTL and EE\_PWMTH parameters. The following table provides typical code for different target PWM frequency and for both low and high speed modes.

| PWM F (Hz) | PWMT (LSB) @13.3MHz | PWM res. (μs) | PWM res. (%) | PWM res. (bit) |
|------------|---------------------|---------------|--------------|----------------|
| 100        | 44333               | 0.240         | 0.0024       | 15             |
| 250        | 17733               | 0.240         | 0.006        | 14             |
| 500        | 8866                | 0.240         | 0.012        | 13             |
| 1000       | 4433                | 0.240         | 0.024        | 12             |

Notes:

- A more accurate trimming can be performed to take into account initial tolerance of the main clock.
- The PWM frequency is subjected to the same tolerances as the main clock (see  $\Delta T_{CK}$ ).

## 14.2. Output Transfer Characteristic

### 14.2.1. Introduction

The main focus of this chapter is the correction over position.

The transfer from magnetic field to output can be optimized by the customer. In the MLX90293ADM, the following three compensation mechanisms have been implemented:

- Piecewise linear compensation of the **thermal sensitivity drift**. A correction factor for the sensitivity can be defined at 7 equidistant temperature points between -50degC and 160degC. Values at other points are linearly interpolated. The parameter names are EE\_Ssys1 up to EE\_Ssys7.
- Piecewise linear compensation of the **thermal offset drift**. A correction value for the offset drift can be defined at 7 equidistant temperature points between -50degC and 160degC. Values at other points are linearly interpolated. The parameter names are EE\_Osys1 up to EE\_Osys7.
- Piecewise linear compensation **over position** (LNR): A value for the desired output can be defined at 17 equidistant magnetic points. The implementation works in two steps:
  - First, the input for the LNR function is achieved by 'stretching' the input signal. Here, the two parameters EE\_DIGGAININ & EE\_DIGOFFSETIN are used
  - Next, the compensation is achieved by the 17 parameters EE\_LNR\_Y0 up to EE\_LNR\_Y16.

The remainder of this chapter assumes the reader knows the following three concepts:

- Signed parameters are in two's complement
- The Digital Signal Processing chain usually calculates with 16 bit numbers. For example, the final compensated digital signal is a value from 0 up to 65535. Any deviation from this rule will be highlighted.
- The following parameter naming convention is used throughout the chapter. Every output of one calculation is the input for the next step, see also next section 14.2.2.

- B1 = input field which comes after the analog to digital converter (Melexis only)
- B2 = signal after Hall-Element Offset compensation (Melexis only)
- B3 = signal after Hall-Element Sensitivity compensation (Melexis only)
- B4 = signal data after Polarity and Filter functions (Melexis only) (=B\_IC\_TC)
- B5a = signal after digital offset and gain functions (customer programmable)
- B7 = signal after system sensitivity compensation (customer programmable)
- B6 = signal after system offset compensation output (customer programmable)
- B5b= signal after the piecewise linear compensation over position (customer programmable)
- B8 = signal after scaling (Melexis only) (=B\_SYS\_TC)
- B9 = signal after clamping (customer programmable)
- B10 = signal for DAC, PWM or SENT (protocol is customer programmable)

### 14.2.2. Order selection of the calculation

A user can select the order of customer selectable calculations. The following table shows the possible sequences. To select, please use the parameter TREATSEQ (see EE\_USERCFG0 in section 14.1.1).

| TREATSEQ[1:0]=0       | TREATSEQ[1:0]=1       | TREATSEQ[1:0]=2       | TREATSEQ[1:0]=3       |
|-----------------------|-----------------------|-----------------------|-----------------------|
| 1. Hall Offset(T)     | 1. Hall Offset(T)     | 1. Hall Offset(T)     | 1. Hall Offset(T)     |
| 2. Hall Sens(T)       | 2. Hall Sens(T)       | 2. Hall Sens(T)       | 2. Hall Sens(T)       |
| 3. Polarity           | 3. Polarity           | 3. Polarity           | 3. Polarity           |
| 4. Filters            | 4. Filters            | 4. Filters            | 4. Filters            |
| 5a. Apply Pre-scaling | 5a. Apply Pre-scaling | 5a. Apply Pre-scaling | 5a. Apply Pre-scaling |
| 5b. LNR               | 6. System Offset(T)   | 5b. LNR               | 7. System Sens(T)     |
| 6. System Offset(T)   | 7. System Sens(T)     | 7. System Sens(T)     | 6. System Offset(T)   |
| 7. System Sens(T)     | 8a. Post scaling      | 6. System Offset(T)   | 8a. Post scaling      |
| 8b. 2x Scaling        | 5b. LNR               | 8a. Post scaling      | 5b. LNR               |
| 8a. Post scaling      | 8b. 2x Scaling        | 8b. 2x Scaling        | 8b. 2x Scaling        |
| 9. Clampings          | 9. Clampings          | 9. Clampings          | 9. Clampings          |
| 10. DAC Map           | 10. DAC Map           | 10. DAC Map           | 10. DAC Map           |

Important: please refer to OutputScaling (see EE\_CALIBMODE\_L in 14.1.1) as this is Post scaling. Apply Pre-scaling uses digital gain and offset with EE\_DIGOFFSETIN & EE\_DIGGAININ whereas Post Scaling uses EE\_DIGOFFSETOUT & EE\_DIGGAINOUT. Users can also enable/disable 8b. 2x Scaling.

### 14.2.3. Piecewise Linear Compensation over Position

The LNR parameters (EE\_LNR\_Y0, ... EE\_LNR\_Y16, and EE\_BPIVOT), together with the clamping values (EE\_CLAMPLOW and EE\_CLAMPHIGH), fully define the relation (the transfer function) between the digital angle and the output signal.

The shape of the MLX90293 transfer function from the digital angle value to the output voltage is described by the drawing below. In the 16 segments mode, the output transfer characteristic is Piece-Wise-Linear (PWL).

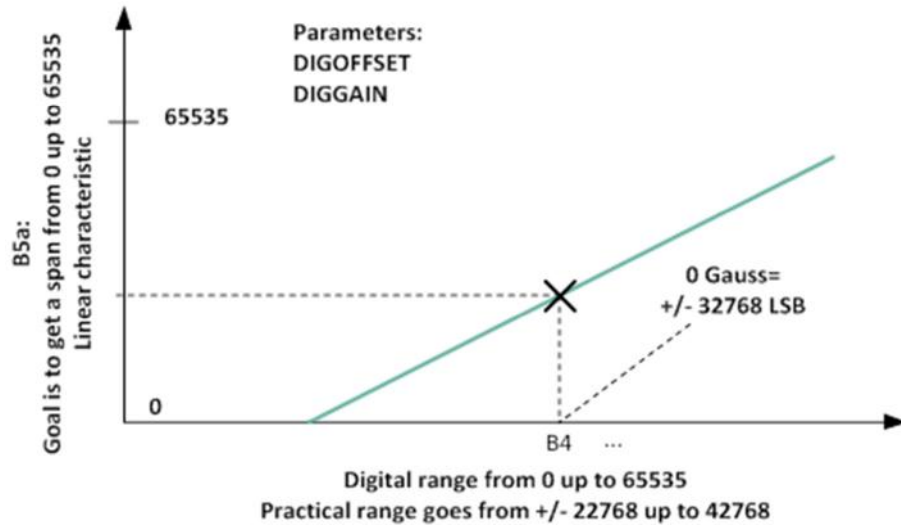


Figure 9a - The input from the analog chain is scaled to ensure a good input range for the piecewise linear compensation in (b)

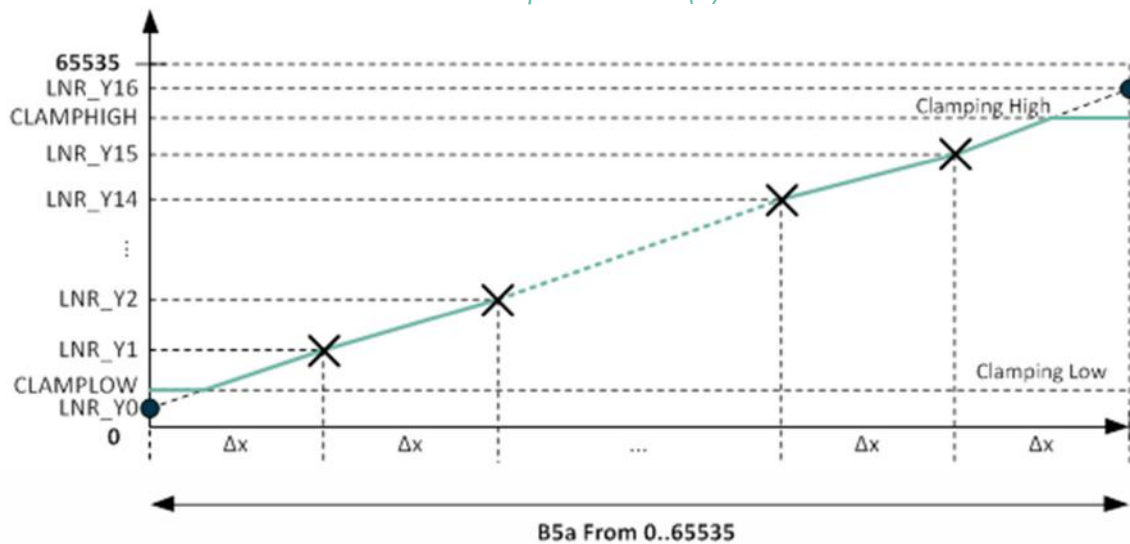


Figure 9b - Input range from 65.5Deg. up to 360Deg.

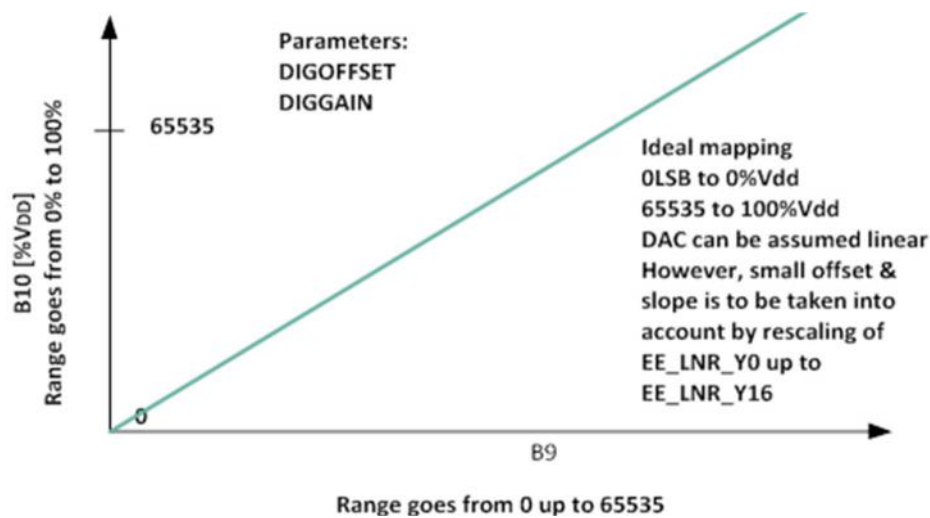


Figure 9c - The OUTPUT4DAC is transformed to an analog output.

Figure 9 (a,b,c) - The graphs show the transfer characteristic of each of the customer configurable parameters.

**IMPORTANT:** customer who only needs a linear relation between magnetic field & output will only deal with EE\_DIGGAINx & EE\_DIGOFFSETx (x=IN or OUT).

The sequence for customer to trim for piecewise linear compensation over position is depicted here:

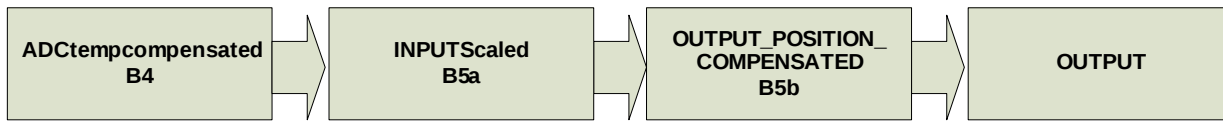


Figure 10 - The following sequence is to be trimmed by customers to enable piecewise linear compensation.

To trim parts, the following steps & equations have to be followed.

#### Step1: Select the Analog Gain code VG

To minimize the quantization errors occurring at the A/D converter, one shall select the highest possible analog gain, and one shall use the digital gain capability to trim the circuit sensitivity in a fine manner.

#### Step2: trim the scaling factors EE\_DIGGAINx & EE\_DIGOFFSETx (x=IN or OUT)

$$B5a = ( B4 - EE\_DIGOFFSETx \cdot 2^8 ) \cdot EE\_DIGGAINx \cdot 2^8 / 2^{10}$$

The following equation is to be used by customers to ensure the span of B5a goes from 0 up to 65535.

#### Step3: trim the piecewise linear coefficients EE\_LNR\_Y0, ... EE\_LNR\_Y16

These coefficients determine the desired output for the 17 equidistant input points. See Figure 9b). Thus, customers program the desired output for these 17 points. The intermediate points come from a linear interpolation.

| Value for LNRy | Output  |
|----------------|---------|
| 0              | -50%Vdd |
| 65535          | 150%Vdd |

### 14.2.4. Piecewise Linear Compensation for Thermal Offset Drift

Customers can trim the system offset drift. The IC's intrinsic offset drift is minimized by Melexis. If you intend to use thermal offset drift for the system –not IC-, please contact Melexis.

This functionality is only available if customer set the parameter EE\_USERCFG1[4]= Select\_Sent\_Osys to 0 (default). Then, the 3 first EEPROM words are used for system offset compensation. Otherwise, the EEPROM content for EE\_OSYS1 up to EE\_OSYS7 can be (optionally) used for SENT communication. Also, the transfer equation also depends on the order defined in section 14.2.2.

$Osys(Tlin) = ( PWL_7(Tlin) / 256 ) \cdot 32$ ,  $PWL_7$  stands for piecewise linear compensation.

The output  $Osys(Tlin)$  is added to the input value.

Here,  $Tlin$  goes from -50degC up to 160degC. The values in the EEPROM are defined in the next table.  $Tlin$  is the temperature as measured by the IC.

| Value for LNRy        | EEPROM parameter |
|-----------------------|------------------|
| $PWL_7(Tlin=-50degC)$ | EE_OSYS1         |
| $PWL_7(Tlin=-15degC)$ | EE_OSYS2         |
| ...                   | ...              |
| $PWL_7(Tlin=125degC)$ | EE_OSYS6         |
| $PWL_7(Tlin=160degC)$ | EE_OSYS7         |

### 14.2.5. Piecewise Linear Compensation for Thermal Sensitivity Drift

Customers can trim the system's sensitivity drift. The IC's intrinsic sensitivity drift is minimized by Melexis. The Melexis tooling helps to minimize the system thermal drift caused by for example, the magnet thermal drift.

The transfer equation also depends on the order defined in section 14.2.2.

$S_{sys}(T_{lin}) = (2^{15} + PWL_7(T_{lin}) / 256 * 128)$  if  $EE\_CALIBMODE\_L[3]=1$ , otherwise  $S_{sys}(T_{lin}) = (2^{15} + PWL_7(T_{lin}) / 256 * 64)$ .  $PWL_7$  stands for piecewise linear compensation. The former enables a correction span from [0.75, 1.248], the latter from [0.5, 1.496].

The output  $S_{sys}(T_{lin}) / 2^{15}$  shows the relative sensitivity change for a given IC temperature  $T_{lin}$ .

Here,  $T_{lin}$  goes from -50degC up to 160degC. The values in the EEPROM are defined in the next table.  $T_{lin}$  is the temperature as measured by the IC.

| Value for LNRy           | EEPROM parameter |
|--------------------------|------------------|
| $PWL_7(T_{lin}=-50degC)$ | EE_SSYS1         |
| $PWL_7(T_{lin}=-15degC)$ | EE_SSYS2         |
| ...                      | ...              |
| $PWL_7(T_{lin}=125degC)$ | EE_SSYS6         |
| $PWL_7(T_{lin}=160degC)$ | EE_SSYS7         |

### 14.2.6. CLAMPING Parameters

The clamping levels are two independent values to limit the output voltage range. The  $EE\_CLAMPLOW$  parameter adjusts the minimum output voltage level. The  $EE\_CLAMPHIGH$  parameter sets the maximum output voltage level. Both parameters have 16 bits of adjustment and are available for both LNR modes. In analog mode, the resolution will be limited by the D/A converter (12 bits) to 0.024%VDD. In PWM mode, the resolution will be 0.024%DC.

## 14.3. SENT output Protocol

### 14.3.1. Generalities

The MLX90293 complies with the sub-set “**A.3 Single Secure Sensors**” of the norm J2716 Revised **JAN2010**.

Remark: A customer has to select either piecewise linear compensation of the offset drift (zero gauss point) or the SENT serial message.

### 14.3.2. Single Secure Fast Channel

MLX90293 delivers SENT frames according the Single Secure format. This format is explicitly described in this section.

- **Frame Content**

The 90293 SENT frames have 6 data nibbles, and are formatted according the below table.

| SENT frame  |        |         |        |        |         |        |     |                |
|-------------|--------|---------|--------|--------|---------|--------|-----|----------------|
| Status[0:3] | D1-MSN | D1-MidN | D1-LSN | D2-MSN | D2-MidN | D2-LSN | CRC | Optional pause |

Where the corresponding frame contents are defined in the table below:

| Content     | description                                                         |
|-------------|---------------------------------------------------------------------|
| Status[0]   | Channel 1 indicator ("1"= error,"0" otherwise) (see section 14.3.2) |
| Status[1]   | 0                                                                   |
| Status[2]   | Enhanced serial Message (see section 14.3.3)                        |
| Status[3]   | Enhanced serial Message (see section 14.3.3)                        |
| CRC         | Enhanced CRC (the legacy CRC is not featured)                       |
| D1          | Position                                                            |
| D2-MSN      | D2-MSN = Rolling Counter - MSN                                      |
| D2-MidN     | D2-MidN = Rolling Counter - MidN                                    |
| D2-LSN      | D2-LSN = Inverted copy of D1-LSN                                    |
| Pause pulse | Pause pulse when activated (see section 14.3.2)                     |

Note: To minimize frame length, the value of the rolling counter can be forced to zero. Overwrite ForceCntrZero (see EE\_SENT\_SERIAL below).

| Byte           | Bit | Function             |                                                                                                                                                                                                                  |
|----------------|-----|----------------------|------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| EE_SENT_SERIAL | 0   | EE_CODE_REPORT[0]    | EE_CODE_REPORT[2:0] controls how diagnostic are reported in channel 1:<br>Channel1 = 4088 + EE_CODE_REPORT[2:0] when in diagnostic and EE_CODE_REPORT>0<br>Channel1 = output value always when EE_CODE_REPORT=0. |
|                | 1   | EE_CODE_REPORT[1]    |                                                                                                                                                                                                                  |
|                | 2   | EE_CODE_REPORT[2]    |                                                                                                                                                                                                                  |
|                | 3   | ForceCntrZero        | ForceCntrZero. in case of True, counter in SENT frame is set to 0 to reduce message length.                                                                                                                      |
|                | 4   | Reserved             |                                                                                                                                                                                                                  |
|                | 5   | Reserved             |                                                                                                                                                                                                                  |
|                | 6   | EE_EXTENDEDESEQUENCE | EE_EXTENDEDESEQUENCE=1 enables the long sequence of slow messages.                                                                                                                                               |
|                | 7   | Not used - 0         |                                                                                                                                                                                                                  |

- Diagnostic Reporting through the fast channel

#### Diagnostic Reporting, bit Status[0]

The bit Status[0] is high whenever the three following conditions are met:

1. A diagnostic (analog/environmental) detects an error<sup>(28)</sup>
2. The reporting of the above error is enabled<sup>(29)</sup>
3. The debouncing time has elapsed.

#### Diagnostic Reporting, Channel 1

The diagnostic can be reported through the 12 bit payload of channel 1, and not only through the status bit Status[0]. The EEPROM parameters EE\_CODE\_REPORT[2:0] controls the diagnostic reporting through channel 1 as follow:

If EE\_CODE\_REPORT[2:0]=0, the channel 1 reports the angle, and not the diagnostic, as if no diagnostic.

The error is reported only thanks to the Status bits.

<sup>28</sup> A diagnostic of type digital cause the circuit to switch in fail-safe-mode

<sup>29</sup> See EEPROM bits EE\_DIAG\_SETTINGS

If  $EE\_CODE\_REPORT[2:0] > 0$ , the channel1 payload contains the value  $Channel1 = (4088 + EE\_CODE\_REPORT[2:0])$

### Diagnostic Reporting Time

The Diagnostic Reporting Time is programmable (defined as multiple of a macro-cycle unit time).

A macro-cycle is a sequence of 20 angle acquisitions, and has a duration of approximately 6 ms.

### Diagnostic Debouncing

The Diagnostic Reporting is debounced. The debouncing parameter are user-programmable, by steps of approximately 6 ms.

### Pause pulse

A pause pulse, as defined by the standard, is present at the end of every frame. The pause pulse mode can be disabled. Please contact our local Melexis representative to obtain the complete procedure for deactivating the pause pulse mode. The pause pulse is adjusted by the circuit so that the frame period is constant.

The field sensing and the frame synchro pulse are in sync.

### Fast Channel CRC

The 90293 features the new recommended implementation.

## 14.3.3. Slow Channel

- Enhanced Serial Message

The circuit encodes the slow messages according the Enhanced Serial Message Format as specified at Chapter 5.2.4.3 of the SENT norm, except for the following restriction:

The configuration bit is always 0, meaning that the payload consists in 12-bit data and 8-bit message ID.

- Serial Message Sequence

The circuit complies with the following sub-set specifications of the norm for pressure sensors

(The norm for the angular sensor case does not specify the serial message format)

| # | 8bit ID | Item                                | 12 bit data | Comments                                                                    |
|---|---------|-------------------------------------|-------------|-----------------------------------------------------------------------------|
| 1 | 29      | Sensor ID                           | Prog.       | EE_USERID1_12LSB                                                            |
| 2 | 01      | Error Code                          | RAM         | Described in section 14.3.3                                                 |
| 3 | 2A      | Sensor ID                           | Prog.       | {EE_USERID2_8LSB, EE_USERID1_4MSB }                                         |
| 4 | 01 / 80 | Error Code / User-defined RAM value | RAM         | RAM variable @ address EE_RAM_PROBE_ADDR e.g. Temp, GainCode, FieldStrength |
| 5 | 2B      | Sensor ID                           | Prog.       | {EE_USERID3_4LSB, EE_USERID2_8 MSB}                                         |
| 6 | 01      | Error Code                          | RAM         |                                                                             |
| 7 | 2C      | Sensor ID                           | Prog.       | EE_USERID3_12MSB                                                            |
| 8 | 01 / 80 | Error Code / User-defined RAM value | RAM         | RAM variable @ address EE_RAM_PROBE_ADDR e.g. Temp, GainCode, FieldStrength |

| #                                       | 8bit ID        | Item                                | 12 bit data      | Comments                                                                       |
|-----------------------------------------|----------------|-------------------------------------|------------------|--------------------------------------------------------------------------------|
| Optional Part (EE_ExtendedSequence = 1) |                |                                     |                  |                                                                                |
| 9                                       | 06             | SENT Revision                       | 003              |                                                                                |
| 10                                      | 01             | Error Code                          | RAM              |                                                                                |
| 11                                      | EE_SERIAL_ID1  | User-defined #1                     | EE_SERIAL_DATA_1 | e.g. Sensor type, Manufacturing code                                           |
| 12                                      | 01 / 80        | Error Code / User-defined RAM value | RAM              | RAM variable @ address EE_RAM_PROBE_ADDR<br>e.g. Temp, GainCode, FieldStrength |
| 13                                      | EE_SERIAL_ID12 | User-defined #2                     | EE_SERIAL_DATA_2 | e.g. 07 – Kennlinie                                                            |
| 14                                      | 01             | Error Code                          | RAM              |                                                                                |
| 15                                      | EE_SERIAL_ID3  | User-defined #3                     | EE_SERIAL_DATA_3 | e.g. 03 – Sensor Type                                                          |
| 16                                      | 01 / 80        | Error Code / User-defined RAM value | RAM              | RAM variable @ address EE_RAM_PROBE_ADDR<br>e.g. Temp, GainCode, FieldStrength |
| 17                                      | EE_SERIAL_ID4  | User-defined #4                     | EE_SERIAL_DATA_4 |                                                                                |
| 18                                      | 01             | Error Code                          | RAM              |                                                                                |

The first part (positions 1 to 8) provides the Error Code and the Sensor ID alternatively. The second part (positions 9 to 18) is optional as a whole enabled with EEPROM bit (EE\_ExtendedSequence=1<sup>(30)</sup>). This second part consists in the error code (5 occurrences), 4 User-defined messages (ID and data) and the SENT revision.

The temperature can be derived from user-defined RAM value (see below), with the following equation:  
 User-defined RAM value =  $8 * (T_{lin}[C] - 35[C]) + 865$  LSB12 when User-defined RAM value = ramTempSens  
 The accuracy of the actual Temperature is around  $\pm 10$  Deg.C.

#### Serial message sequence period

| Sequence Length (serial message count) | Sequence Length (frame count) | Sequence Period (ms, typical) |
|----------------------------------------|-------------------------------|-------------------------------|
| 8                                      | 144                           | 121                           |
| 18                                     | 324                           | 273                           |

#### User-defined RAM Value

The payloads of the positions 4, 8 (and 12, 16 if relevant) are user-defined. Three possibilities:

- Error Code
- 12 LSB of a user-defined RAM value
- 12 MSB of a user-defined RAM value
- The positions 4, 12, 16, 20 refer to the same user-defined RAM address.

Thus, customers may choose to send the user-defined RAM Values of the following parameter.

| Variable name | Address | Description              |
|---------------|---------|--------------------------|
| ramTempSens   | 42      | Temperature sensor value |

<sup>30</sup> See EE\_SENT\_SERIAL in section 14.3.2

## Error Code Rate

The Error Code are on purpose transmitted every second message, to maximize the rate, which equals then 36 SENT frames, when the user-defined RAM mode is not enabled (72 otherwise).

- Serial Message Error Code

The Serial error code contains the error

| Bit position | Diagnostic   | Comments                                 |
|--------------|--------------|------------------------------------------|
| 3            | ADCSatura    | Diagnostic                               |
| 4            | ADCMonitor   | ADC monitor                              |
| 5            | VanaMoni     | Analog Internal Supply Too Low           |
| 6            | VddMoni      | External Supply Too Low, Too High        |
| 7            | Rough Offset | Front-end Rough Offset too low, too high |
| 8            | TempMonitor  | Temperature Sensor monitor               |

### 14.3.4. Start-up

During the chip initialization the output remains high until the circuit emits four initialization frames (all 6 data nibble zero). The fifth frame is not an initialization frame but a valid frame containing a measured angle.

See also the section 8, "Timing Specification".

### 14.3.5. Field sensing (A2D conversions) and the frame Synchro pulse

The digital output value (fast channel payload) results of the average of two values. These values are themselves computed from 4 ADCs values.

The time between the ADCs and the frame synchro pulse is constant. As a result the phase delay between the magnetic field value and the SENT synchro pulse is constant, allowing filtering at the ECU side.

See also section 8, "Timing Specification".

## 14.4. Identification

| Parameter  | Value     |
|------------|-----------|
| EE_USERID1 | 0...65535 |
| EE_USERID2 | 0...65535 |
| EE_USERID3 | 0...65535 |

Identification number: 48 bits (3 words) freely useable by Customer for traceability purpose.

## 14.5. Lock

The MEMLOCK write protects all the EEPROM parameters set by the Melexis and user<sup>(31)</sup>. Once the lock is enabled, it is not possible to change the EEPROM values anymore.

Note that the Memlock bits should be set by the solver function "MemLock".

---

<sup>31</sup> See EE\_USERCFG2 in section 14.1.1

## 14.6. Digital Filter

### 14.6.1. Introduction

The MLX90293ADM offers both a Finite Impulse Response Filter and an Infinite Impulse Response Filter. Here, IIR filters are considered better for closed looped systems as these have a smaller parasitic phase delay. To enable extreme noise reduction, customers can also combine an IIR filter with a hard threshold.

### 14.6.2. Specification & EEPROM settings

The table below gives the response time of the different filters for a step change.

| Filter Type   | Relative Noise Reduction Factor | Phase Delay (#samples) | 90% Response Delay vs No Filter (#samples) |
|---------------|---------------------------------|------------------------|--------------------------------------------|
| No filter     | 1                               | 0                      | $\Delta = 0$                               |
| FIR(1,1)      | 1:0.707                         | 0.5                    | $\Delta = 0$                               |
| FIR (1,1,1,1) | 1:0.500                         | 1.5                    | $\Delta = 3$                               |
| IIR_K=2,      | 1:0.578                         | < 1                    | $\Delta = 3$                               |
| IIR_K=2.66,   | 1:0.480                         | 0 . 1.6                | $\Delta = 4$                               |
| IIR_K=4       | 1:0.379                         | < 3                    | $\Delta = 7$                               |

See the table below how the minimal step change is defined in case of a hard threshold.

| EEPROM parameter            | Description               | EEPROM value | comment                                                                                                     |
|-----------------------------|---------------------------|--------------|-------------------------------------------------------------------------------------------------------------|
| FILTER <sup>(32)</sup> (2b) | No filter                 | 0            |                                                                                                             |
|                             | FIR(1,1)                  | 1            |                                                                                                             |
|                             | FIR (1,1,1,1)             | 2            |                                                                                                             |
|                             | 1 <sup>st</sup> order IIR | 3            | Can be combined with Hard Threshold. Important, set also IIR_K                                              |
| IIR_K <sup>(33)</sup> (2b)  | k=2                       | 8000h        | IIR filter where k is used for transfer function<br>$y_n = y_{n-1} + (x_n - y_{n-1})/k$<br>Filter = (1<<16) |
|                             | k=2.66                    | 603E         |                                                                                                             |
|                             | k=4                       | 4000         |                                                                                                             |
|                             | k=8                       | 2000         |                                                                                                             |
|                             | k=16                      | 1000         |                                                                                                             |

### 14.6.3. Hard Threshold

The hard threshold enables bypassing the IIR filter during a fast field change. This field change is a user definable threshold called “Hard Threshold”. This setting is recommended in applications where strong filtering is beneficial and where immediate response is wanted during extreme position changes of the sensor. However, this behaviour is non linear, so careful testing is recommended if this setting is used in a closed feedback system.

Using this feature requires enabling EnableHardThreshold<sup>(32)</sup> and setting the value for the parameter Hard Threshold. To define, measure the noise of B\_IC\_TC at a fixed position under normal operation. Then, the 6 times the standard deviation of this signal’s variation will determine the hard threshold value.

<sup>32</sup> See EE\_USERCFG1 in section 14.1.1

<sup>33</sup> See section 13

## 14.7. Programmable Diagnostic Settings

### 14.7.1. DIAG mode

Defines the Output Stage mode in case of Diag.

| OS_DIAG.mode [2:0] | Type    | Descriptions    | Comments        |
|--------------------|---------|-----------------|-----------------|
| 0                  | Disable | Output HiZ      | Not recommended |
| 5                  | Digital | open drain NMOS |                 |
| 6                  | Digital | open drain PMOS |                 |
| 7                  | Digital | Push-Pull       |                 |

### 14.7.2. DIAG Level

Determines the reporting level (diagnostic low, diagnostic high) during start-up (both analog and PWM mode), or during a fault reporting (Only in Analog mode).

In PWM mode, the fault reporting level shall in principle be 0 when the leading edge is a rising edge, (resp. 1 for a falling edge) in order to detect the first cycle after start-up. MLX recommends then DIAG Level = PWMPOL.

### 14.7.3. Diagnostic Features

It is recommended to enable the diagnostic features for safety critical applications. See section 15.

## 14.8. EEPROM endurance

Although the EEPROM is used for Calibration Data Storage (similarly to an OTPROM), the MLX90293 embedded EEPROM is qualified to guarantee an endurance of minimum 1000 write cycles at 125°C for (engineering/calibration purpose).

## 15. Self Diagnostic

The MLX90293 provides numerous self-diagnostic features. Those features increase the robustness of the IC functionality as it will prevent the IC to provide erroneous output signal in case of internal or external failure modes ("fail-safe").

| Diagnostic Item                                                    | Action                                          | Effect on Outputs                         | Type             | Monitoring Rate              | Reporting Rate                                                                      |
|--------------------------------------------------------------------|-------------------------------------------------|-------------------------------------------|------------------|------------------------------|-------------------------------------------------------------------------------------|
| <b>Start-up phase Diagnostics</b>                                  |                                                 |                                           |                  |                              |                                                                                     |
| RAM March C-10N Test                                               | Fail-safe mode **<br>** CPU reset after 120ms   | Diagnostic low/ high Reporting (optional) | Digi HW          | n/applicable (start-up only) | n/applicable (start-up only)                                                        |
| Watchdog BIST                                                      | Fail-safe mode **<br>** CPU reset after 120ms   | Diagnostic low/ high Reporting (optional) | Digi HW          | n/applicable (start-up only) | n/applicable (start-up only)                                                        |
| Under Voltage Monitoring<br><i>SUPPLYMONI = (MT3VB) OR (MT4VB)</i> | Start-up on Hold **<br>** CPU reset after 120ms | Diagnostic low/high                       | Environ & Analog | n/applicable (start-up only) | n/applicable (start-up only)                                                        |
| Over Voltage Monitoring<br><i>MT7V</i>                             | PTC entry                                       | Output in High-Impedance                  | Environ          | n/applicable (start-up only) | n/applicable (start-up only)                                                        |
| <b>Back-Ground Loop Diagnostics</b>                                |                                                 |                                           |                  |                              |                                                                                     |
| ROM 16bit checksum (continuous)                                    | Fail-safe mode **<br>** CPU reset after 120ms   | Diagnostic low//high Reporting (optional) | Digi HW          | $80 \cdot DTI_{DIG}$         | $80 \cdot DTI_{DIG}$                                                                |
| EEPROM 8 bit CRC Check (continuous)                                | Fail-safe mode **<br>** CPU reset after 120ms   | Diagnostic low/high Reporting (optional)  | Digi HW          | $1 \cdot DTI_{DIG}$          | $1 \cdot DTI_{DIG}$                                                                 |
| Watchdog (continuous)                                              | CPU reset                                       | --                                        | Digi HW          | 120ms                        | n/a                                                                                 |
| <b>DSP Loop Diagnostics</b>                                        |                                                 |                                           |                  |                              |                                                                                     |
| ADC Clipping<br><i>ADCCLIP<sup>(34)</sup></i>                      | Debouncing (programmable)                       | SENT Status bit0 = 1 (optional)           | Environ & Analog | 5/DSP                        | $\frac{DTIANA \times \text{Diag\_Debounce\_Thresh}}{\text{Diag\_Debounce\_Stepup}}$ |
| ADC Monitor (Analog to Digital Converter)<br><i>ADCMONI</i>        | Debouncing (programmable)                       | SENT Status bit0 = 1 (optional)           | Analog HW        | 1/DSP                        | $\frac{DTIANA \times \text{Diag\_Debounce\_Thresh}}{\text{Diag\_Debounce\_Stepup}}$ |

*34 Diagnostic disabled per default. In order to reach the diagnostic coverage as described in the safety manual, this diagnostic needs to be enabled after completing the setting of the analog gain, see footnote 18. Please contact Melexis for more information.*

| Diagnostic Item                                                        | Action                           | Effect on Outputs               | Type             | Monitoring Rate        | Reporting Rate                                                           |
|------------------------------------------------------------------------|----------------------------------|---------------------------------|------------------|------------------------|--------------------------------------------------------------------------|
| Under Voltage Monitoring<br>$SUPPLYMONI = (MT3VB) \text{ OR } (MT4VB)$ | Supply Debouncing (programmable) | SENT Status bit0 = 1 (optional) | Environ & Analog | 1/DSP                  | $DTI_{ANA} \times \frac{Diag\_Debounce\_Thresh}{Diag\_Debounce\_Stepup}$ |
| Over Voltage Monitoring<br>$MT7V$                                      | PTC entry after PTC Debouncing   | Output in High-Impedance        | Environ          | $8/20 \cdot DTI_{ANA}$ | $8/20 \cdot DTI_{ANA}$                                                   |
| Temperature Sensor Monitor<br>$TEMPMONI$                               | Debouncing (programmable)        | SENT Status bit0 = 1 (optional) | Analog           | 1/DSP                  | $DTI_{ANA} \times \frac{Diag\_Debounce\_Thresh}{Diag\_Debounce\_Stepup}$ |

**Hardware Diagnostics ( continuously checked by dedicated Logic )**

|                                                     |                                               |                     |         |                        |                             |
|-----------------------------------------------------|-----------------------------------------------|---------------------|---------|------------------------|-----------------------------|
| Read/Write Access out of physical memory            | Fail-safe mode **<br>** CPU reset after 120ms | Diagnostic Low/High | Digi HW | n/a<br>immediate Diag  | n/a<br>immediate Diagnostic |
| Write Access to protected area (IO and RAM Words)   | Fail-safe mode **<br>** CPU reset after 120ms | Diagnostic low/high | Digi HW | n/a<br>immediate Diag. | n/a<br>immediate Diagnostic |
| Unauthorized Mode Entry                             | Fail-safe mode **<br>** CPU reset after 120ms | Diagnostic low/high | Digi HW | n/a<br>immediate Diag  | n/a<br>immediate Diagnostic |
| EEPROM Error Correcting Code ( Hamming correction ) | (Transparent) Error Correction                | No effect           | Digi HW | n/a.                   | n/a                         |

**Hardware Diagnostics ( continuously checked by dedicated Analog circuits )**

|                      |                       |                                                                      |         |                             |                              |
|----------------------|-----------------------|----------------------------------------------------------------------|---------|-----------------------------|------------------------------|
| Broken VSS           | CPU Reset on recovery | Pull down load => Diagnostic High<br>Pull up load => Diagnostic High | Environ | n/a<br>immediate Diagnostic | n/a<br>immediate Diagnostic  |
| Broken VDD           | CPU Reset on recovery | Pull down load => Diagnostic Low<br>Pull up load => Diagnostic Low   | Environ | n/a<br>immediate Diagnostic | n/a<br>immediate Diagnostic  |
| Resistive Cable Test | Start-up on Hold      | Diagnostic low/high                                                  | Environ | n/a<br>immediate Diagnostic | n/a<br>immediate Diagnostic. |

| Dimension   | Min | Typ | Max         | Unit |
|-------------|-----|-----|-------------|------|
| $DTI_{ANA}$ | 5.7 | 6.0 | 6.3         | ms   |
| $DTI_{DIG}$ | 3.9 | 7.2 | $10^{(35)}$ | ms   |

Table 3 - Timing Specification @13.16 MHz

35 DTIDIG (eg. 10ms worst case) Corresponds to 20 output refresh time (eg. 500μs)

## 16. Recommended Application Diagrams

### 16.1. MLX90293 in SOIC-8 Package

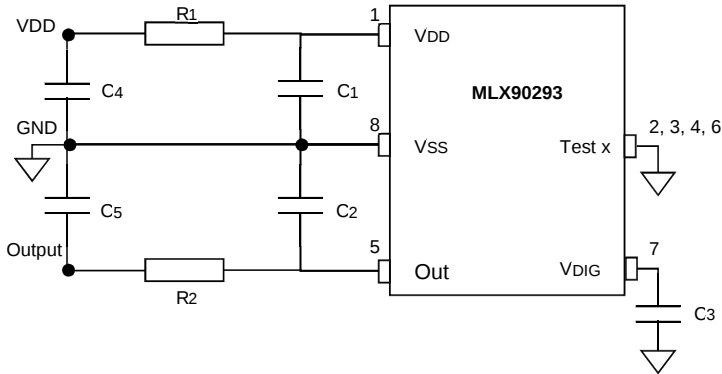


Figure 11 – Recommended wiring for the MLX90293 in SOIC-8 package

| Output        | Compact PCB routing |        |        | EMC robust PCB routing |        |        |                            |
|---------------|---------------------|--------|--------|------------------------|--------|--------|----------------------------|
| Analog Output | Min                 | Typ.   | Max    | Min                    | Typ.   | Max    | Remarks                    |
| C1            | 100 nF              | 100 nF | 1 uF   | 47 nF                  | 100 nF | 1 uF   | Close to the pin           |
| C2 (20)       | 47 nF               | 100 nF | 330 nF | 47 nF                  | 100 nF | 330 nF | Close to the pin           |
| C3            | 47 nF               | 100 nF | 220 nF | 47 nF                  | 100 nF | 220 nF | Close to the pin           |
| C4            | -                   | -      | -      | 500 pF                 | 1 nF   | 10 nF  | Connector Side             |
| C5            | -                   | -      | -      | 500 pF                 | 1 nF   | 10 nF  | Connector Side             |
| R1            | -                   | -      | -      | 0 Ω                    | 10 Ω   | 33 Ω   | Increased ratiometry error |
| R2            | -                   | -      | -      | 10 Ω                   | 50 Ω   | 100 Ω  |                            |

Table 4 - Recommended capacitances for the MLX90293 in analog output mode for SOIC-8 package

| Output     | Compact PCB routing |        |        | EMC robust PCB routing |        |        |                                |
|------------|---------------------|--------|--------|------------------------|--------|--------|--------------------------------|
| PWM Output | Min                 | Typ.   | Max    | Min                    | Typ.   | Max    | Remarks                        |
| C1         | 100 nF              | 100 nF | 1 uF   | 47 nF                  | 100 nF | 1 uF   | Close to the pin               |
| C2         | 2.2 nF              | 4.7 nF | 22 nF  | 2.2 nF                 | 4.7 nF | 22 nF  | Close to the pin               |
| C3         | 47 nF               | 100 nF | 220 nF | 47 nF                  | 100 nF | 220 nF | Close to the pin               |
| C4         | -                   | -      | -      | 500 pF                 | 1 nF   | 10 nF  | Connector Side                 |
| C5         | -                   | -      | -      | 500 pF                 | 1 nF   | 2.2 nF | Connector Side                 |
| R1         | -                   | -      | -      | 0 Ω                    | 10 Ω   | 33 Ω   | Impacts the Voltage on VDD pin |
| R2         | -                   | -      | -      | 10 Ω                   | 50 Ω   | 100 Ω  |                                |

Table 5 - Recommended capacitances for the MLX90293 in PWM mode for SOIC-8 package

| Output | Compact PCB routing |        |        | EMC robust PCB routing |        |        |                                |
|--------|---------------------|--------|--------|------------------------|--------|--------|--------------------------------|
| SENT   | Min                 | Typ.   | Max    | Min                    | Typ.   | Max    | Remarks                        |
| C1     | 100 nF              | 100 nF | 1 uF   | 47 nF                  | 100 nF | 1 uF   | Close to the pin               |
| C2     | 2.2 nF              | 4.7 nF | 22 nF  | 2.2 nF                 | 4.7 nF | 22 nF  | Close to the pin               |
| C3     | 47 nF               | 100 nF | 220 nF | 47 nF                  | 100 nF | 220 nF | Close to the pin               |
| C4     | -                   | -      | -      | 500 pF                 | 1 nF   | 10 nF  | Connector Side                 |
| C5     | -                   | -      | -      | 500 pF                 | 1 nF   | 2.2 nF | Connector Side                 |
| R1     | -                   | -      | -      | 0 Ω                    | 10 Ω   | 33 Ω   | Impacts the Voltage on VDD pin |
| R2     | -                   | -      | -      | 10 Ω                   | 50 Ω   | 100 Ω  |                                |

Table 6 - Recommended capacitances for the MLX90293 in SENT mode for SOIC-8 package

## 16.2. MLX90293 in TSSOP-16 Package

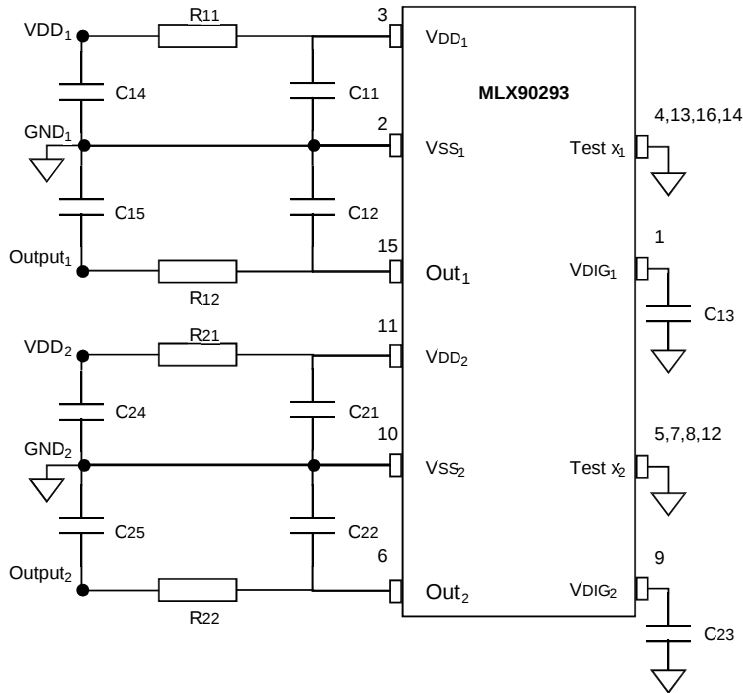


Figure 12 – Recommended wiring for the MLX90293 in TSSOP-16 package

| Output        | Compact PCB routing |        |        | EMC robust PCB routing |        |        | Remarks                    |
|---------------|---------------------|--------|--------|------------------------|--------|--------|----------------------------|
| Analog Output | Min                 | Typ.   | Max    | Min                    | Typ.   | Max    |                            |
| C11, C21      | 100 nF              | 100 nF | 1 uF   | 47 nF                  | 100 nF | 1 uF   | Close to the pin           |
| C12, C22      | 47 nF               | 100 nF | 330 nF | 47 nF                  | 100 nF | 330 nF | Close to the pin           |
| C13, C23      | 47 nF               | 100 nF | 220 nF | 47 nF                  | 100 nF | 220 nF | Close to the pin           |
| C14, C24      | -                   | -      | -      | 500 pF                 | 1 nF   | 10 nF  | Connector Side             |
| C15, C25      | -                   | -      | -      | 500 pF                 | 1 nF   | 10 nF  | Connector Side             |
| R11, R21      | -                   | -      | -      | 0 Ω                    | 10 Ω   | 33 Ω   | Increased ratiometry error |
| R12, R22      | -                   | -      | -      | 10 Ω                   | 50 Ω   | 100 Ω  |                            |

Table 7 - Recommended capacitances for the MLX90293 in ANALOG mode for TSSOP-16 package

| Output     | Compact PCB routing |        |        | EMC robust PCB routing |        |        | Remarks                        |
|------------|---------------------|--------|--------|------------------------|--------|--------|--------------------------------|
| PWM Output | Min                 | Typ.   | Max    | Min                    | Typ.   | Max    |                                |
| C11, C21   | 100 nF              | 100 nF | 1 uF   | 47 nF                  | 100 nF | 1 uF   | Close to the pin               |
| C12, C22   | 2.2 nF              | 4.7 nF | 22 nF  | 2.2 nF                 | 4.7 nF | 22 nF  | Close to the pin               |
| C13, C23   | 47 nF               | 100 nF | 220 nF | 47 nF                  | 100 nF | 220 nF | Close to the pin               |
| C14, C24   | -                   | -      | -      | 500 pF                 | 1 nF   | 10 nF  | Connector Side                 |
| C15, C25   | -                   | -      | -      | 500 pF                 | 1 nF   | 2.2 nF | Connector Side                 |
| R11, R21   | -                   | -      | -      | 0 Ω                    | 10 Ω   | 33 Ω   | Impacts the Voltage on VDD pin |
| R12, R22   | -                   | -      | -      | 10 Ω                   | 50 Ω   | 100 Ω  |                                |

Table 8 - Recommended capacitances for the MLX90293 in PWM mode for TSSOP-16 package

| Output      | Compact PCB routing |        |        | EMC robust PCB routing |             |              |                                |
|-------------|---------------------|--------|--------|------------------------|-------------|--------------|--------------------------------|
| SENT Output | Min                 | Typ.   | Max    | Min                    | Typ.        | Max          | Remarks                        |
| C11, C21    | 100 nF              | 100 nF | 1 uF   | 47 nF                  | 100 nF      | 1 uF         | Close to the pin               |
| C12, C22    | 22 nF               | 4.7 nF | 22 nF  | 2.2 nF                 | 4.7 nF      | 22 nF        | Close to the pin               |
| C13, C23    | 47 nF               | 100 nF | 220 nF | 47 nF                  | 100 nF      | 220 nF       | Close to the pin               |
| C14, C24    | -                   | -      | -      | 500 pF                 | 1 nF        | 10 nF        | Connector Side                 |
| C15, C25    | -                   | -      | -      | 500 pF                 | 1 nF        | 2.2 nF       | Connector Side                 |
| R11, R21    | -                   | -      | -      | 0 $\Omega$             | 10 $\Omega$ | 33 $\Omega$  | Impacts the Voltage on VDD pin |
| R12, R22    | -                   | -      | -      | 10 $\Omega$            | 50 $\Omega$ | 100 $\Omega$ |                                |

*Table 9 - Recommended capacitances for the MLX90293 in SENT mode for TSSOP-16 package*

## 17. Standard information regarding manufacturability of Melexis products with different soldering processes

Our products are classified and qualified regarding soldering technology, solderability and moisture sensitivity level according to standards in place in Semiconductor industry.

For further details about test method references and for compliance verification of selected soldering method for product integration, Melexis recommends reviewing on our web site the General Guidelines [soldering recommendation](#). For all soldering technologies deviating from the one mentioned in above document (regarding peak temperature, temperature gradient, temperature profile etc), additional classification and qualification tests have to be agreed upon with Melexis.

For package technology embedding trim and form post-delivery capability, Melexis recommends to consult the dedicated trim&form recommendation application note: [lead trimming and forming recommendations](#)

Melexis is contributing to global environmental conservation by promoting **lead free** solutions. For more information on qualifications of **RoHS** compliant products (RoHS = European directive on the Restriction Of the use of certain Hazardous Substances) please visit the quality page on our website: <http://www.melexis.com/en/quality-environment>

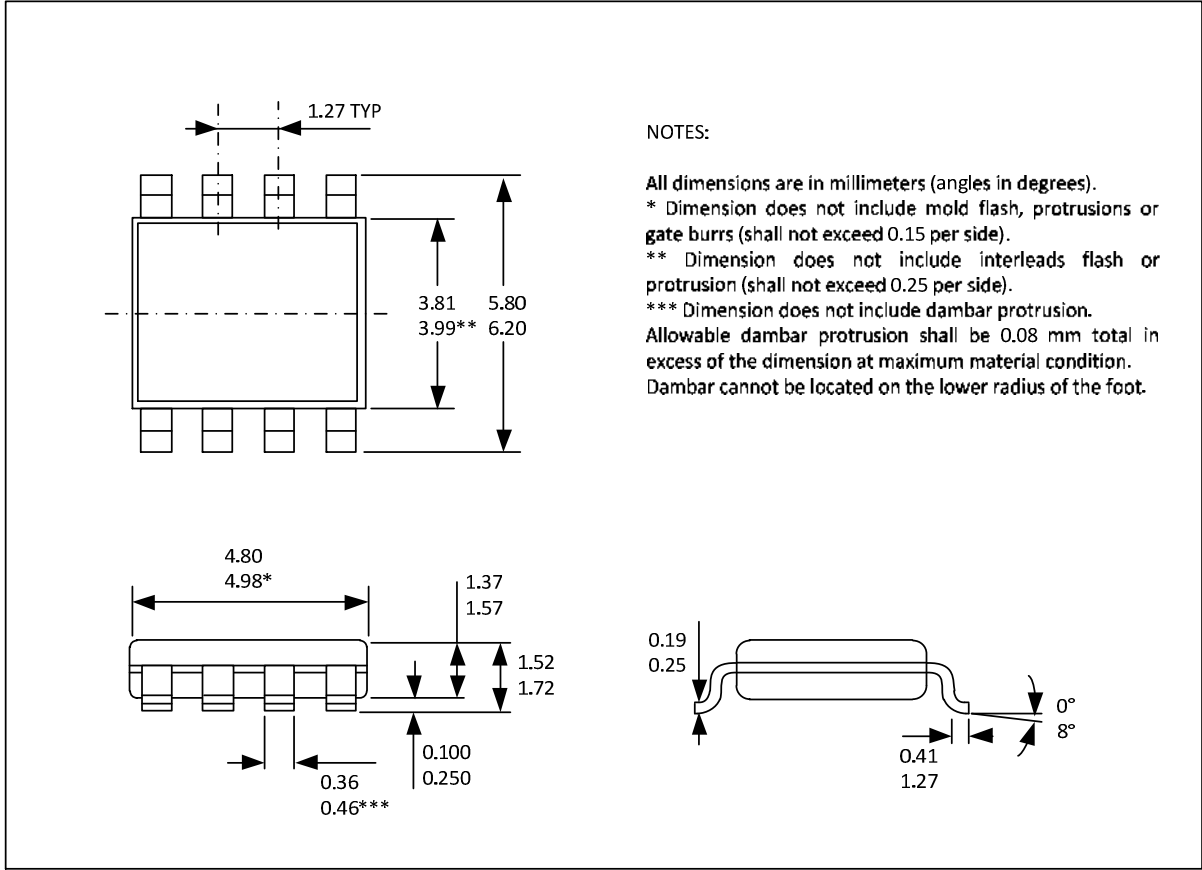
## 18. ESD Precautions

Electronic semiconductor products are sensitive to Electro Static Discharge (ESD).

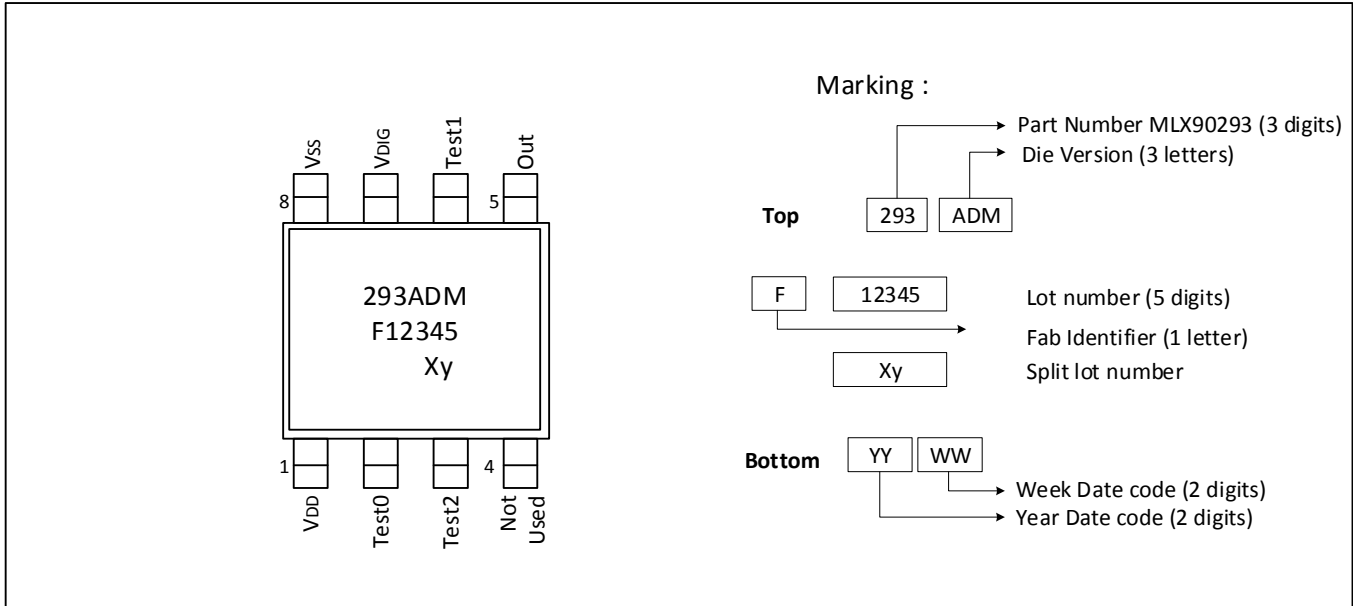
Always observe Electro Static Discharge control procedures whenever handling semiconductor products.

# 19. Package Information

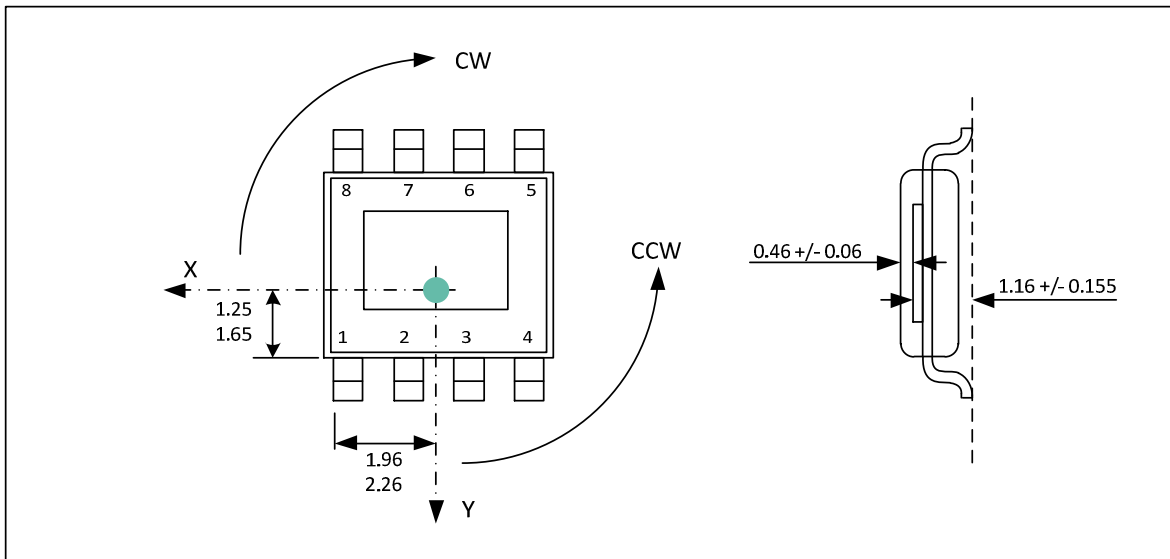
## 19.1. SOIC-8 - Package Dimensions



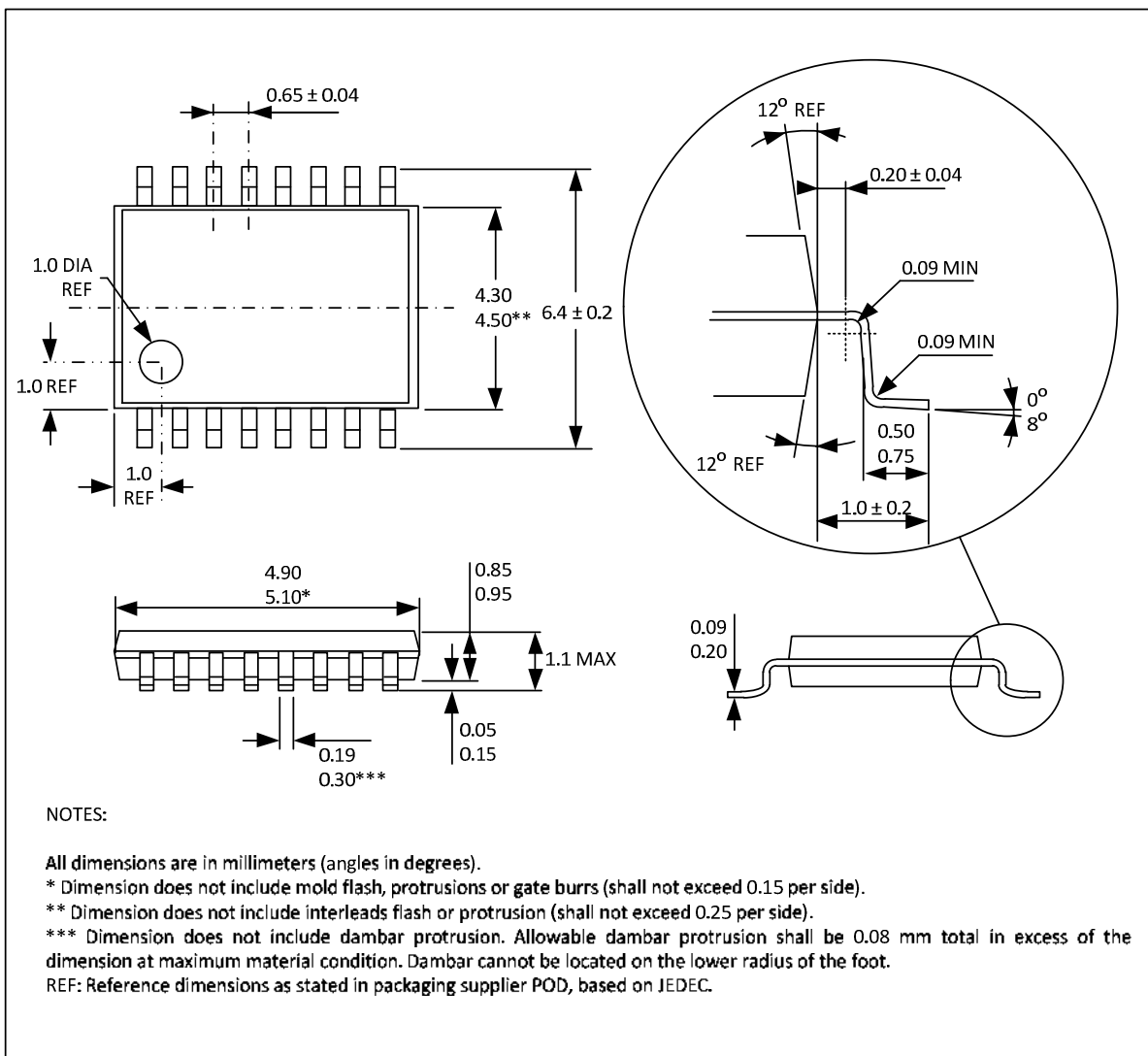
## 19.2. SOIC-8 - Pinout and Marking



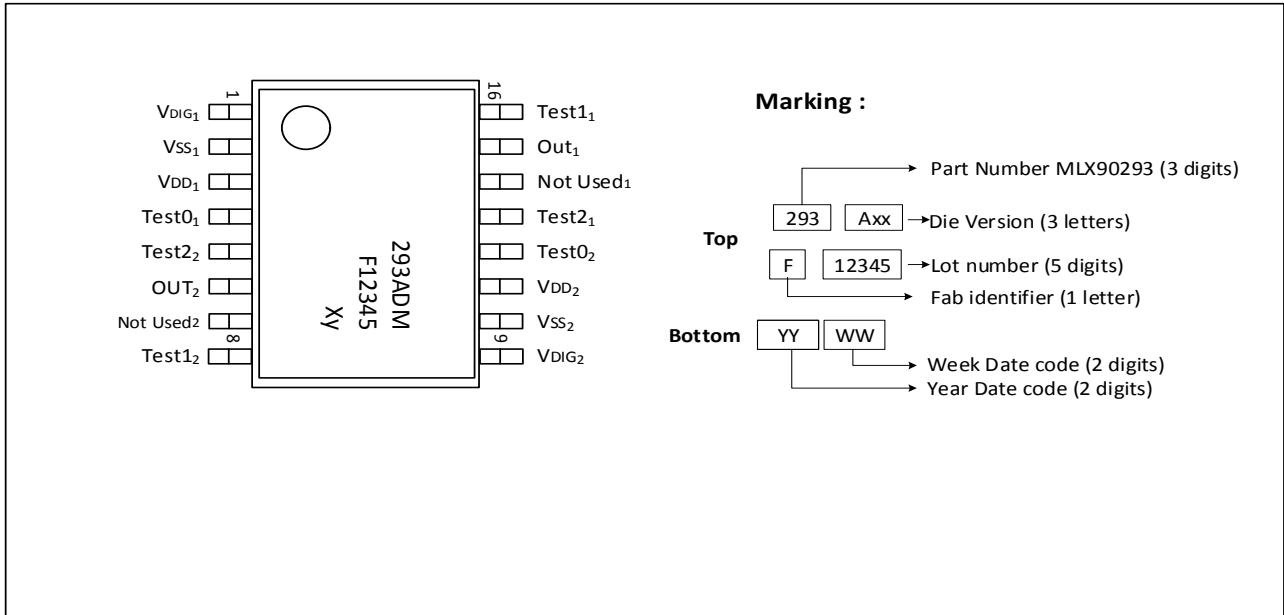
### 19.3. SOIC-8 - Sensitive spot positioning



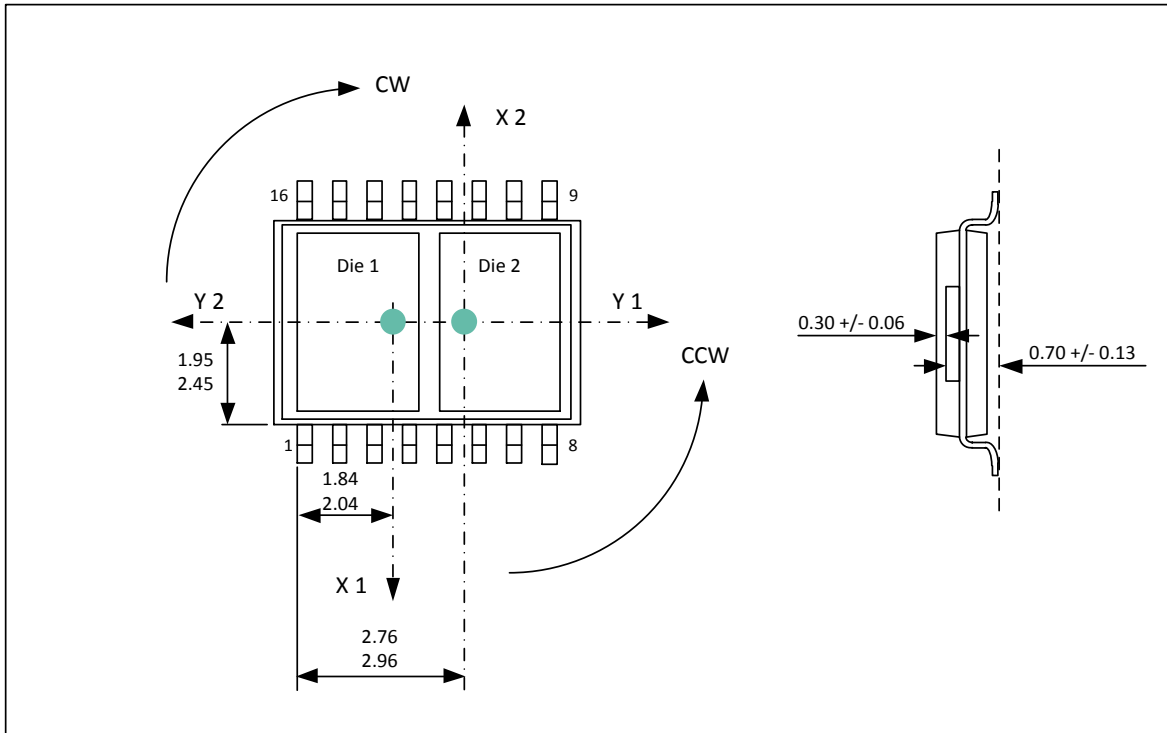
### 19.4. TSSOP-16 - Package Dimensions



## 19.5. TSSOP-16 - Pinout and Marking



## 19.6. TSSOP-16 - Sensitive spot positioning



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